

# MANUFACTURABLE SOLUTIONS FOR WAFER-LEVEL LASER AND SOA INTEGRATION ON SILICON

WORK IN PROGRESS IN EUROPE

Roel Baets

AIM PHOTONICS FALL 2018 ROADMAP MEETING,  
Boston, Dec 28-30, 2018

December 2018 | Volume 106 | Number 12

# Proceedings OF THE IEEE

SPECIAL ISSUE

## Silicon Photonics

Point of View: Thinking About the Robot Takeover

Scanning Our Past: Debugging the ENIAC

# ECIO 2019

24th April - 26th April 2019  
Ghent University, Belgium



Paper submission now open (deadline: 18 January 2019)

**21st EUROPEAN CONFERENCE  
ON INTEGRATED OPTICS**

# THE PAST 5-10 YEARS: STUNNING INDUSTRIAL DEVELOPMENT IN SILICON PHOTONICS, DRIVEN BY TELECOM/DATACOM

- active optical cables (eg PSM4: 4x28 Gb/s on parallel fibers)
- WDM transceivers (eg 4 WDM channels x 25 Gb/s on single fiber)
- coherent receiver (eg 100 Gb/s PM-QPSK)
- fiber-to-the-home bidirectional transceiver (eg 12 x 2.5 Gb/s)
- monolithic receiver (eg 16x20Gb/s)
- 40Gb/s, 50Gb/s and 100 Gb/s Ethernet (future: 400Gb/s)
- ...



# OUTLINE

## ePIXfab

The options for light source integration

Work in progress in Europe

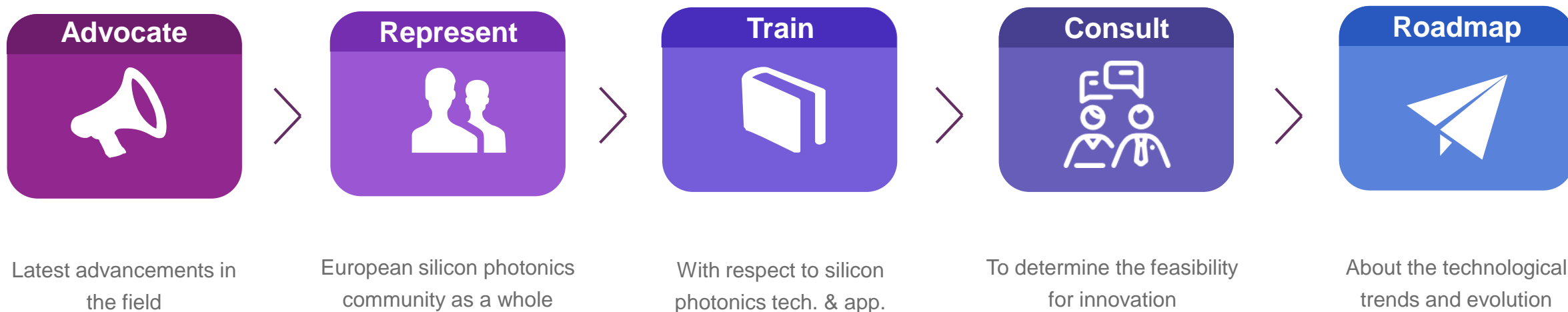
- Short term to market

- Long term to market

- Medium term to market

# ePIXfab: European Alliance for Silicon Photonics

ePIXfab is an open alliance of European organizations that promotes silicon photonics science, technology and applications



# ePIXfab Member Portfolio

Coordinator



Fabs.



Design Tools



Design Houses



Technology Brokers



Epi



Packaging



Industrial Consortium



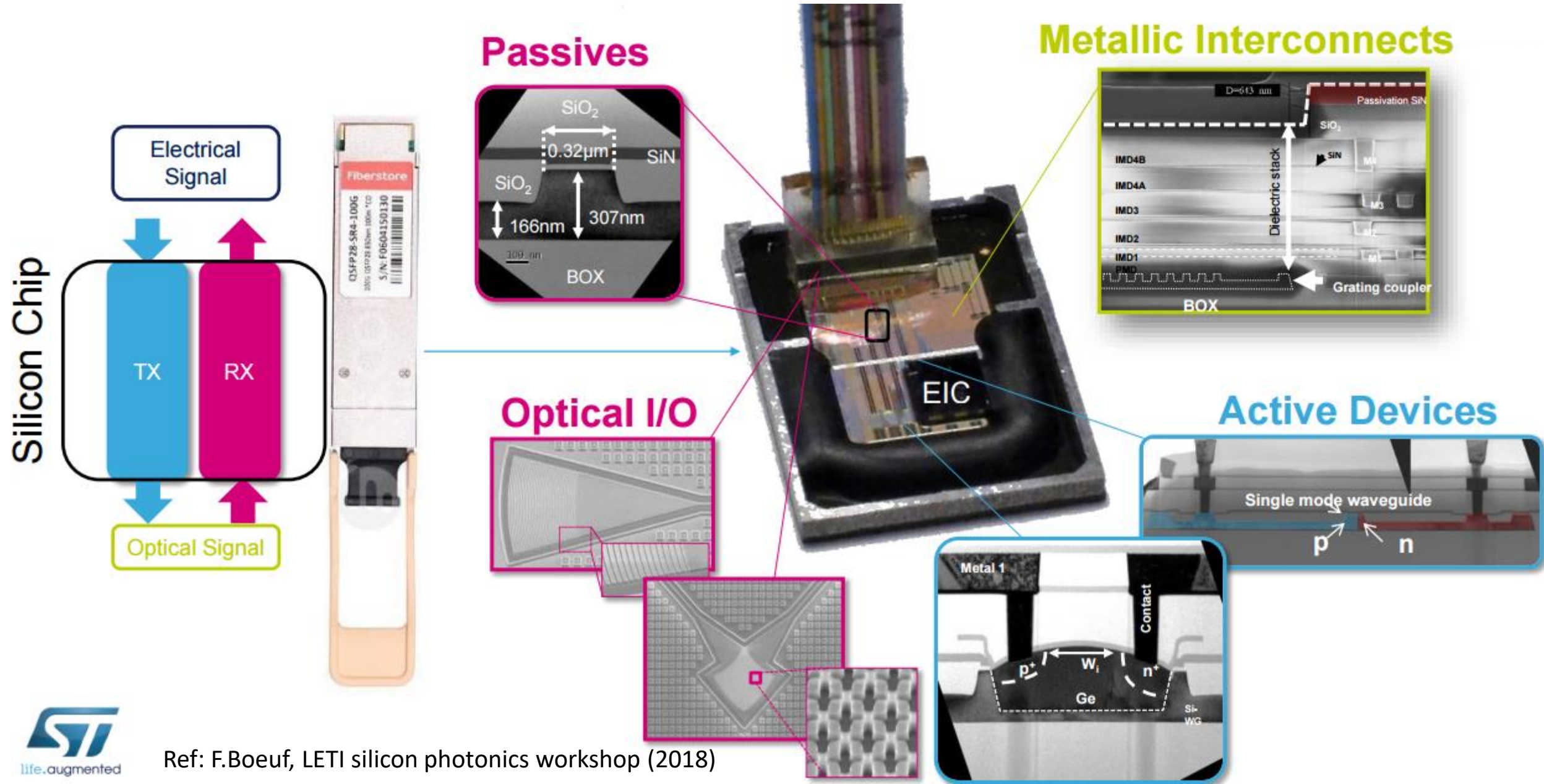
Academic Research



The European Silicon Photonics Alliance

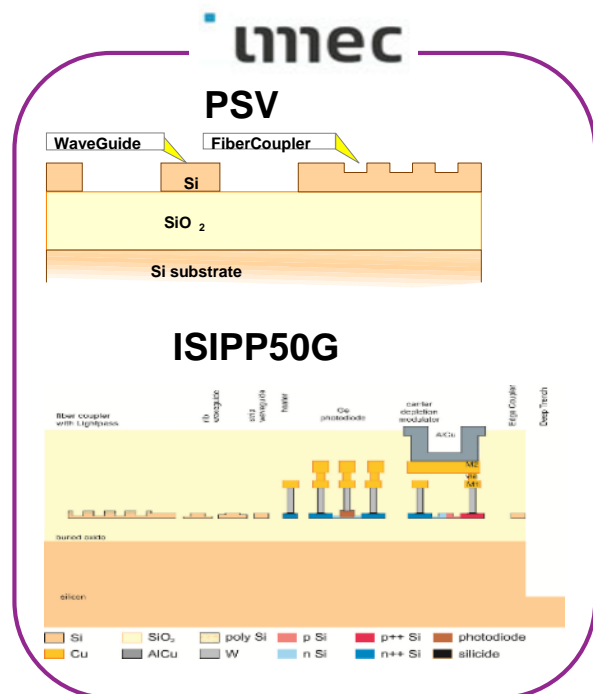
<http://epixfab.eu>

# ST's 100G PSM4 - PIC25G Technology



# Standardized Open Access SOI Technologies

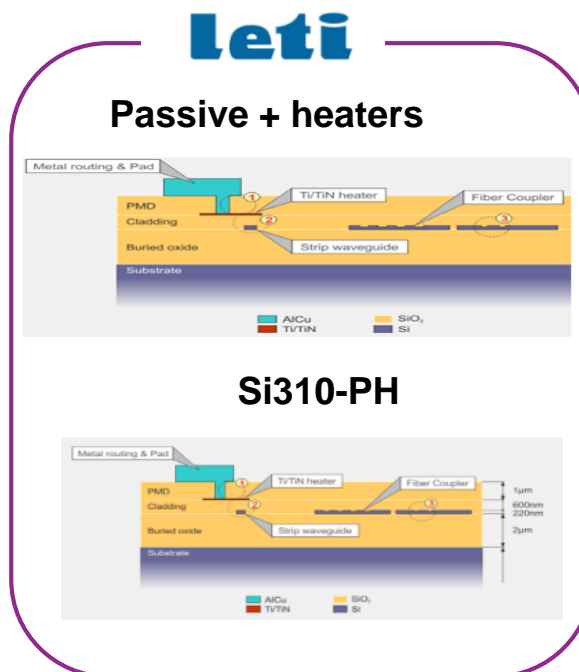
*Accessible through MPW and dedicated engineering runs*



**220 nm SOI platform**

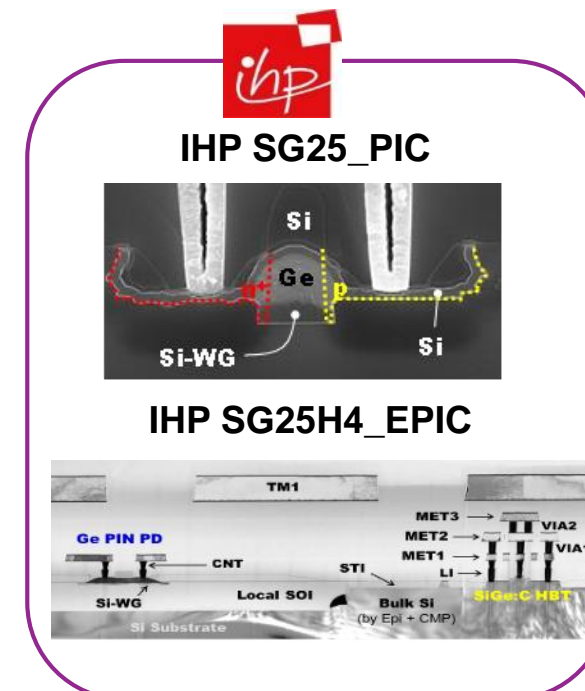
*O/C band*

*50G active devices*



**310 nm SOI platform**

*O/C band devices compatible  
for III-V laser integration*



**Photonic BiCMOS**

*Monolithic integration C-band  
& BiCMOS (190GHz HBT)*

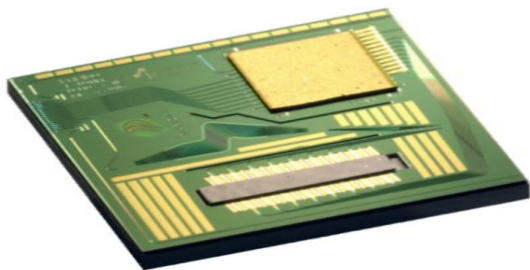
# Standardized Open Access SOI Technologies

*Accessible through MPW and dedicated engineering runs*

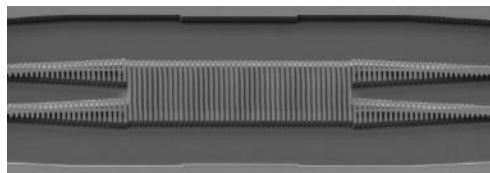
*Rapid prototyping services*

**VTT**

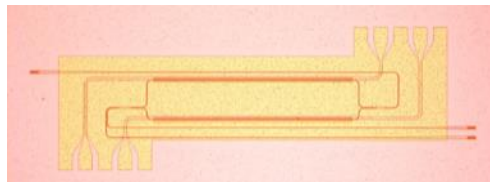
Passives  
+ Implanted heaters  
+ Implanted PIN  
+ Flip-chip



Passive + heaters



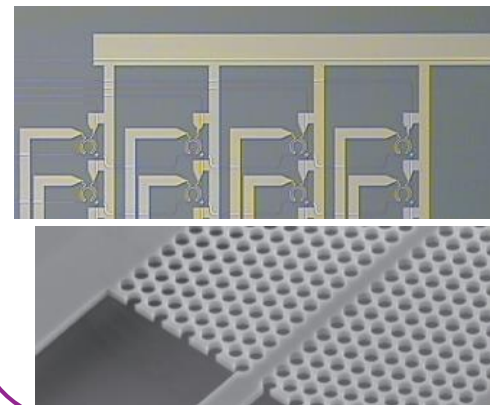
Actives



UNIVERSITY OF  
**Southampton**



Actives+Passives on 220nm  
And 340 nm SOI using e-beam



**Thick SOI**

*low loss + pol. independent*

**Flexible platform**

*custom implants, etch depth*

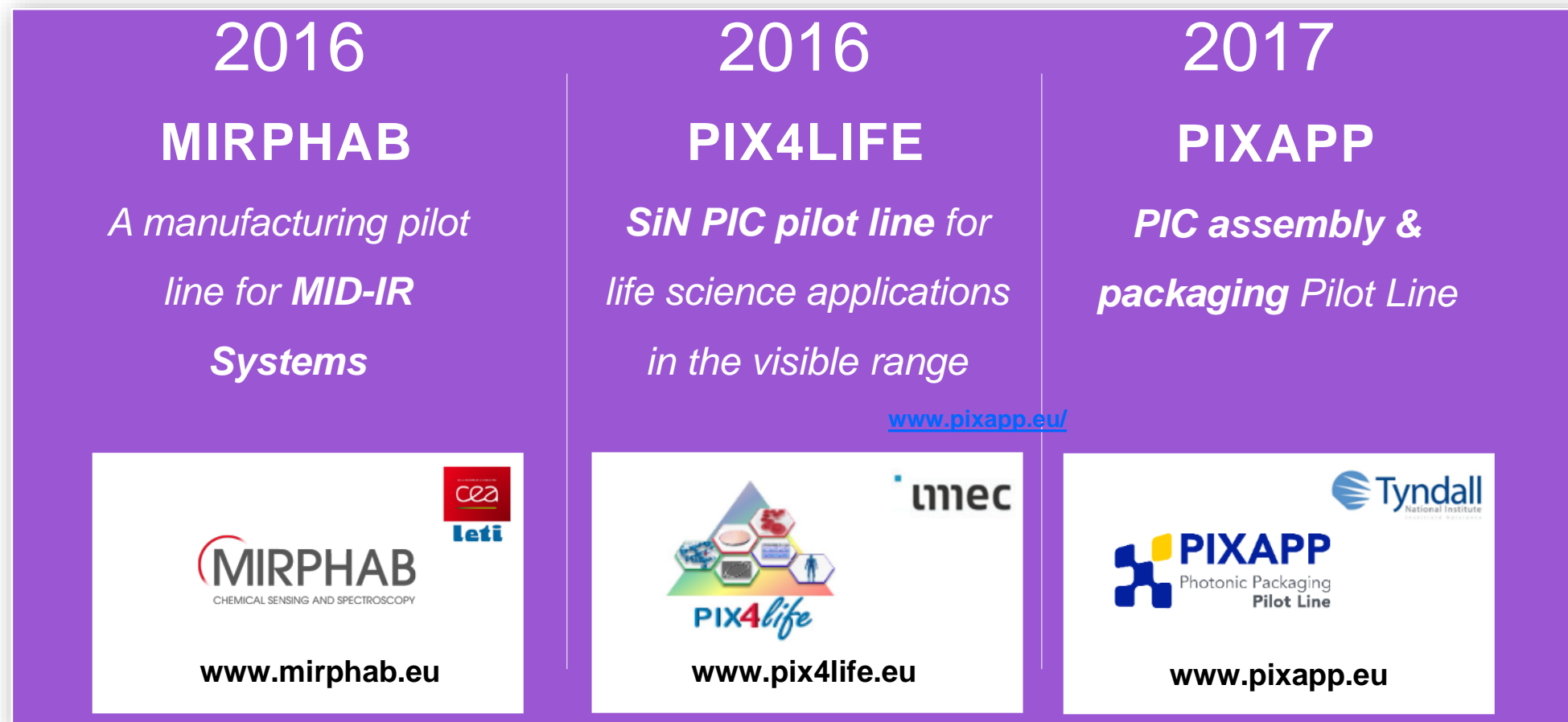
*Multiple SOI platforms*

**Flexible foundry platform**

*for customized wafer runs*

# Pilot lines and coordinating institutes

To strengthen open access mechanisms to photonic integration technology, driven by the needs of end users.



# Take-home message

- There is diversity in silicon photonics
  - Silicon layer thickness
  - Operation at different wavelengths
  - Integration with electronics, or not
  - Heterogeneous integration with III-V, or not
- This diversity brings substantial value to the end-user
- ... as long as the “dilution” caused by diversity is not jeopardizing yield or cost
- **Where is the sweet spot between diversity and standardization?**

# OUTLINE

ePIXfab

➔ The options for light source integration

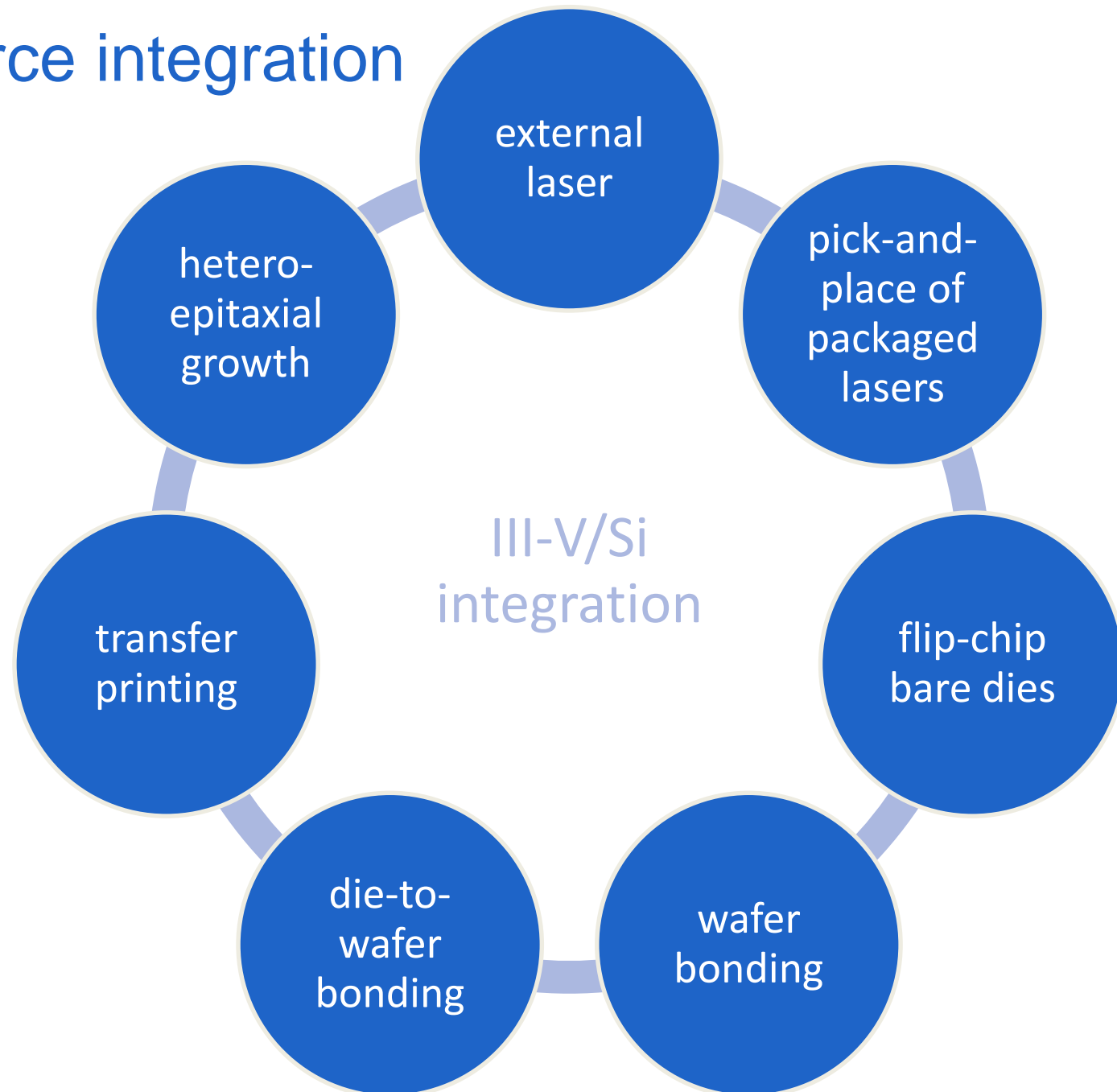
Work in progress in Europe

Short term to market

Long term to market

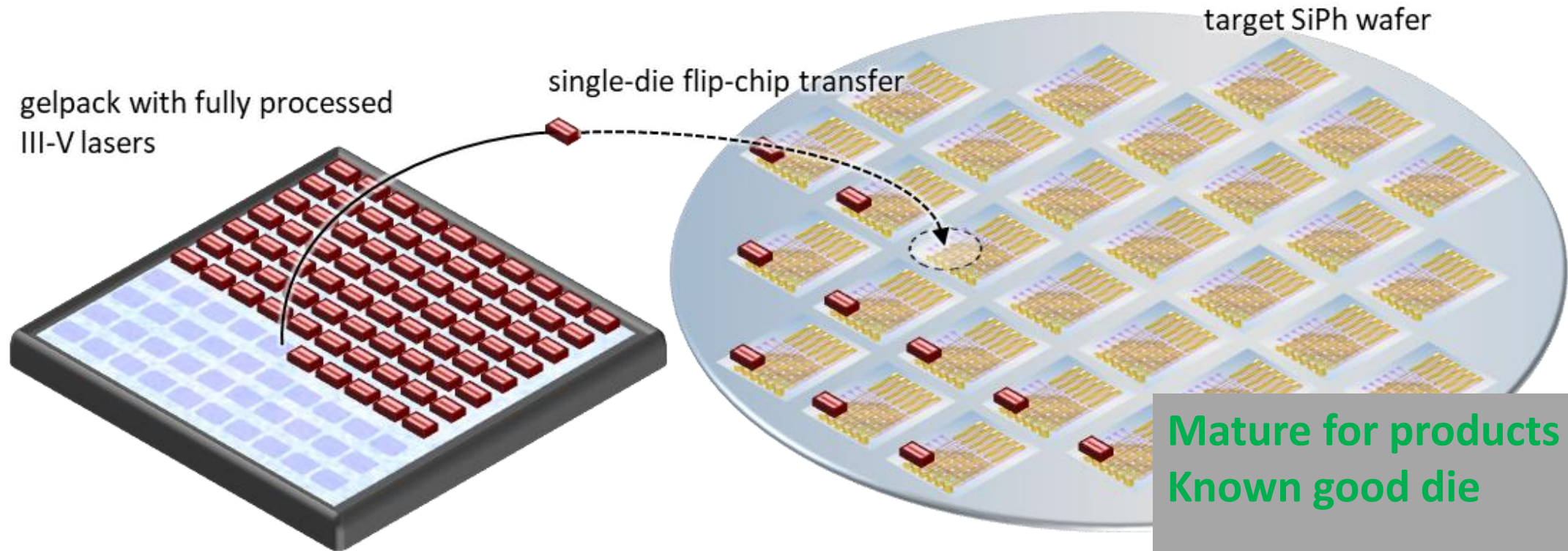
Medium term to market

# Options for light source integration



# Approaches to hybrid III-V integration on SiPhotonics

Flip-chip integration of bare dies / pick-and-place of packaged devices

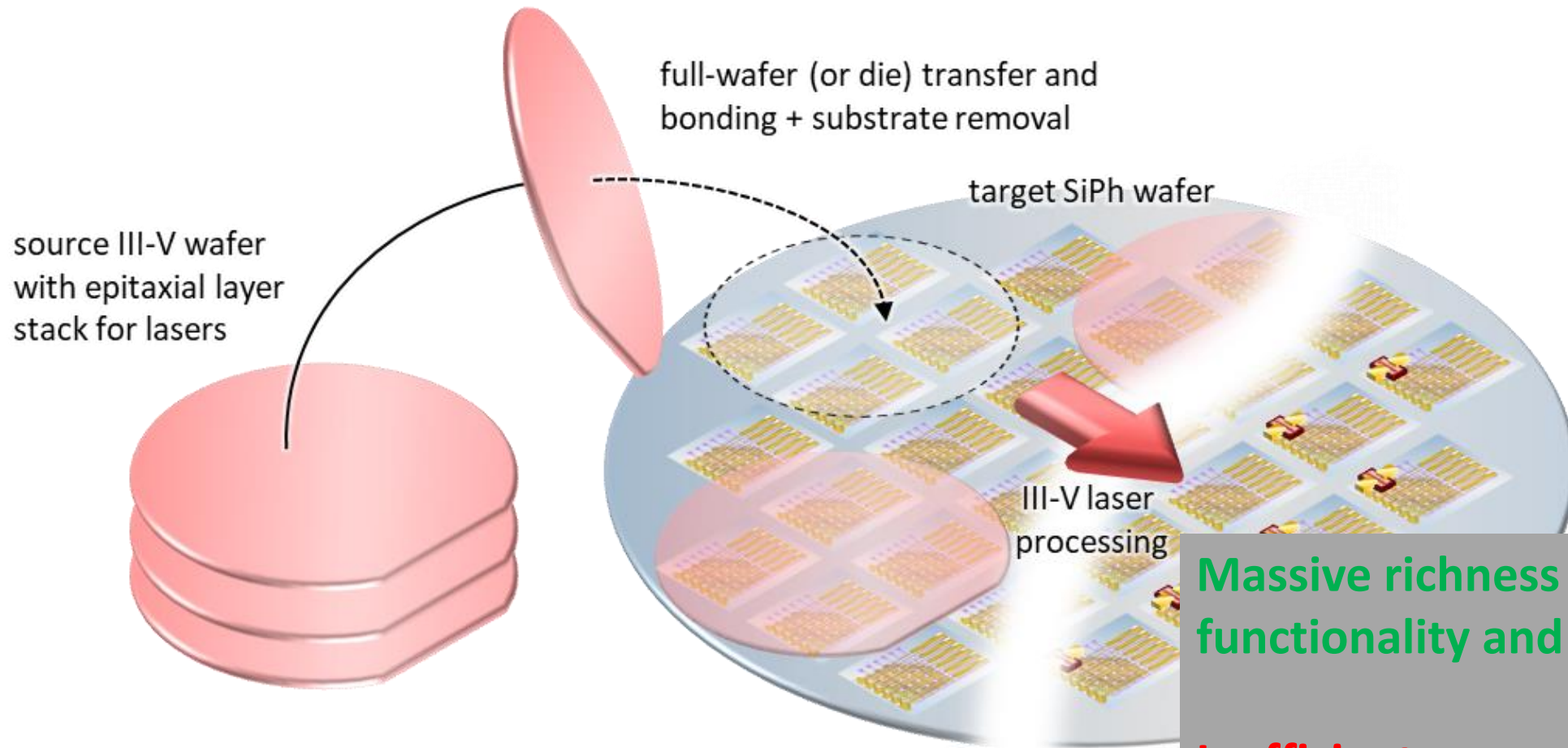


Mature for products today  
Known good die

Not scalable to very low cost  
SOAs are challenging

# Approaches to hybrid III-V integration on SiPhotonics

die-to-wafer and wafer-to-wafer bonding + III-V processing in silicon fab

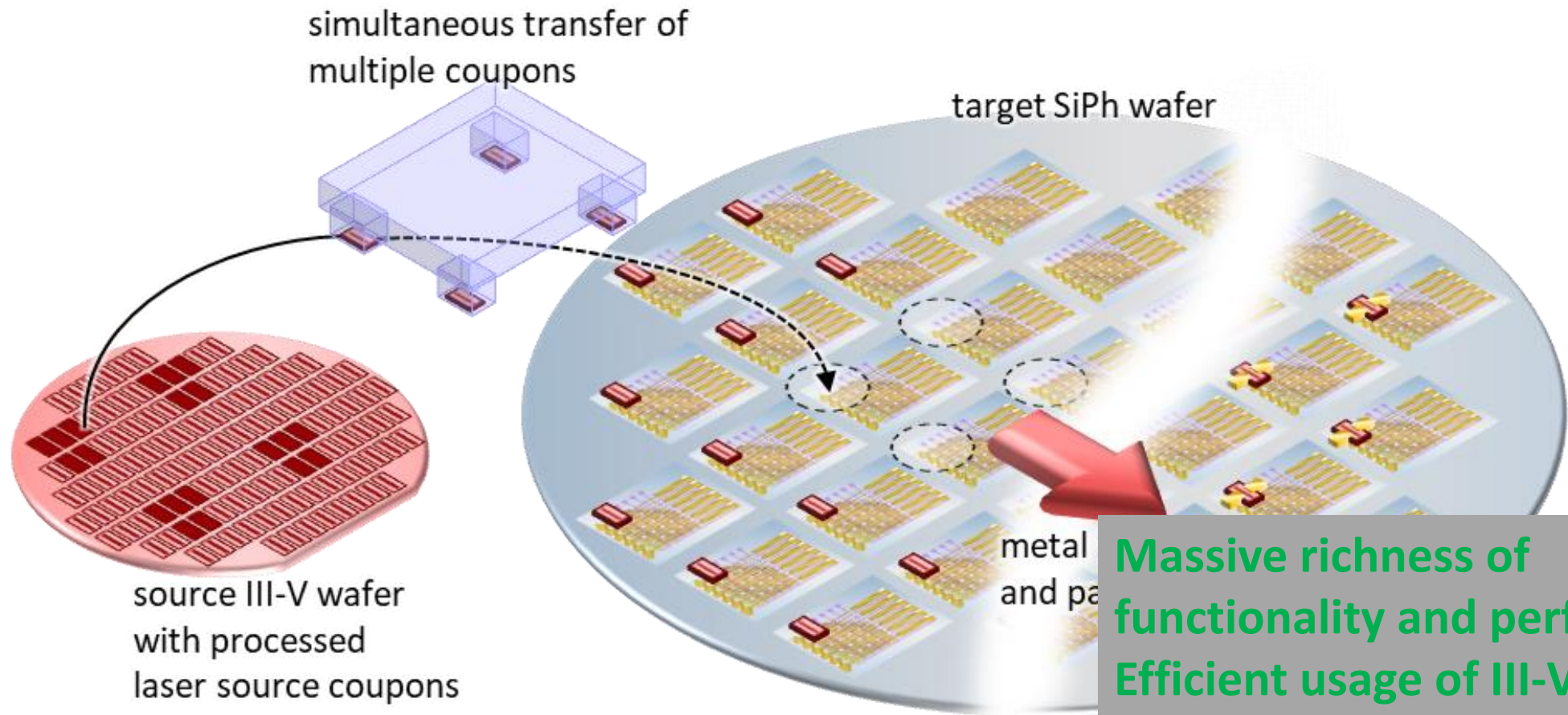


**Massive richness of  
functionality and performance**

**Inefficient usage of III-V  
Very high NRE costs**

# Approaches to hybrid III-V integration on SiPhotonics

## Transfer printing



**Massive richness of functionality and performance**  
**Efficient usage of III-V**  
**Low cost**  
**Reliability to be proven**

## TAKE-HOME MESSAGE

There is a large diversity in approaches for light source integration in silicon photonics

Some are in commercial products today (flip-chip, bonding)

Others are very much at the research level (epitaxy, transfer printing)

**The hunt is still open for a method, implemented in an industrial foundry, that combines scalability to high volume and low cost with high long-term reliability**

# OUTLINE

ePIXfab

The options for light source integration

➡ Work in progress in Europe

Short term to market

Long term to market

Medium term to market

# OUTLINE

ePIXfab

The options for light source integration

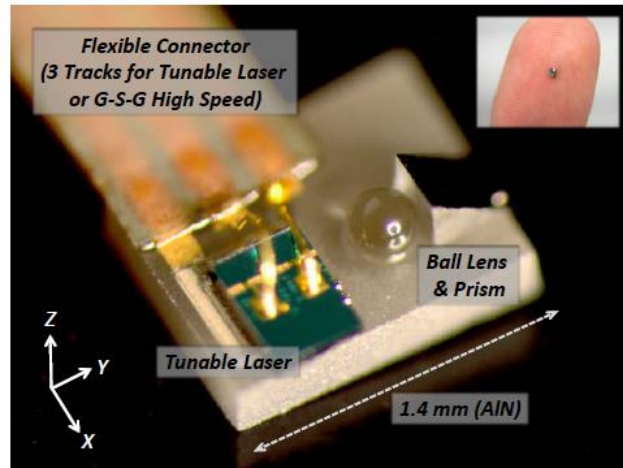
Work in progress in Europe

➡ Short term to market

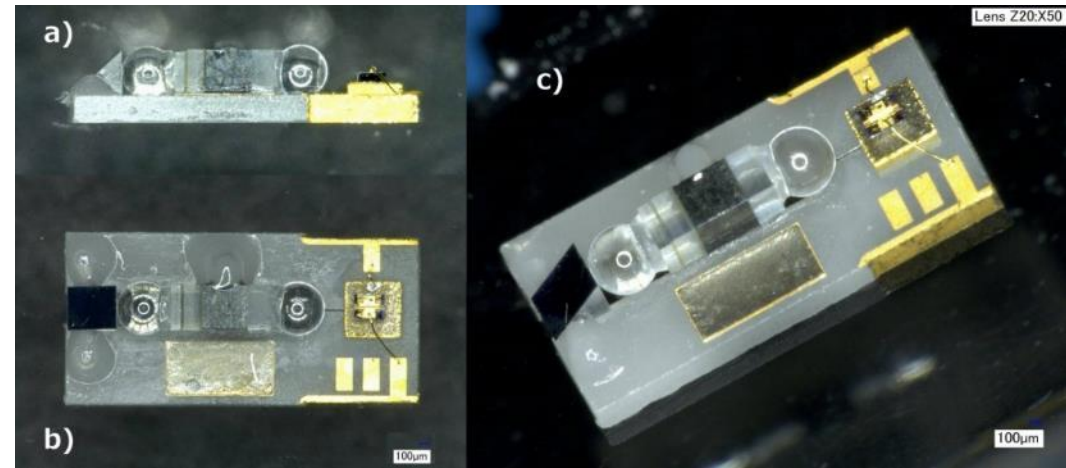
Long term to market

Medium term to market

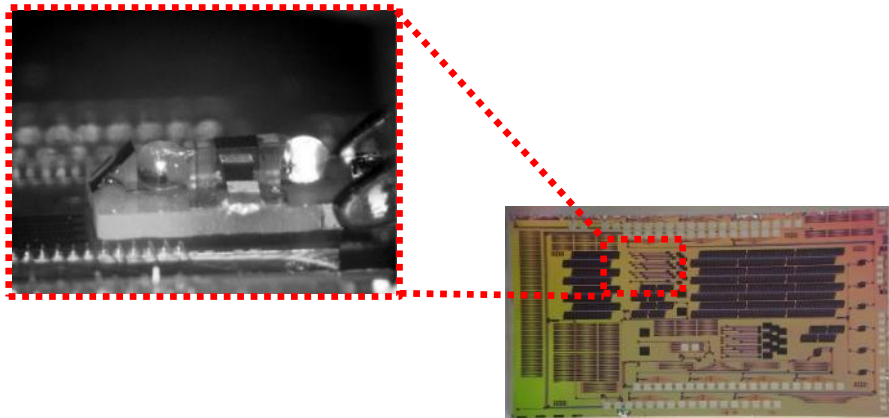
# Pick-and-Place Laser Integration – Edge Emitters



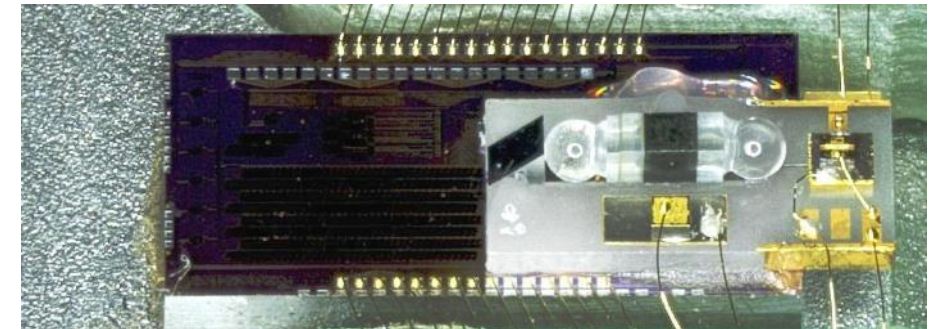
Standard Micro Optical Bench



Micro Optical Bench with Isolator



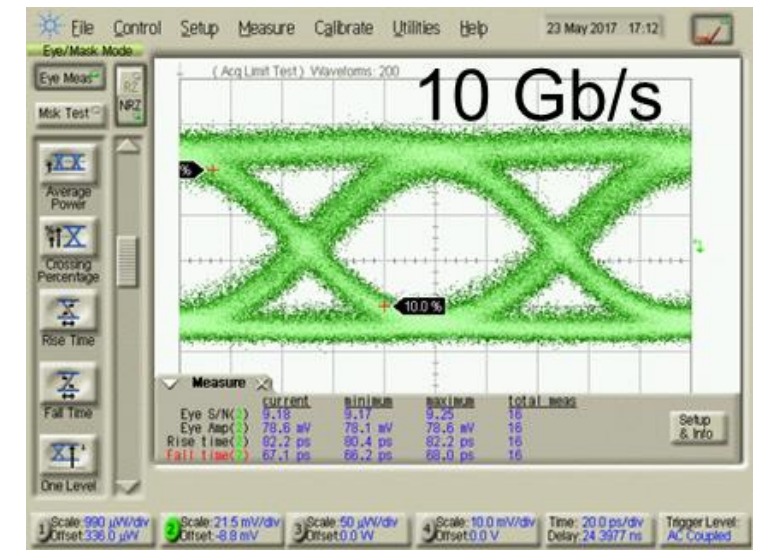
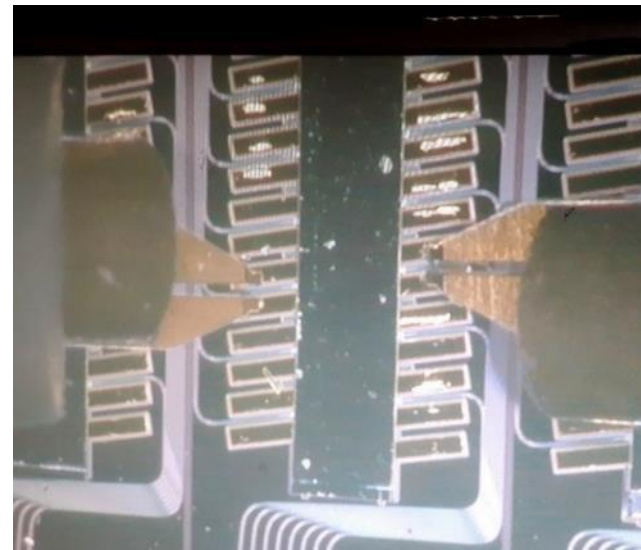
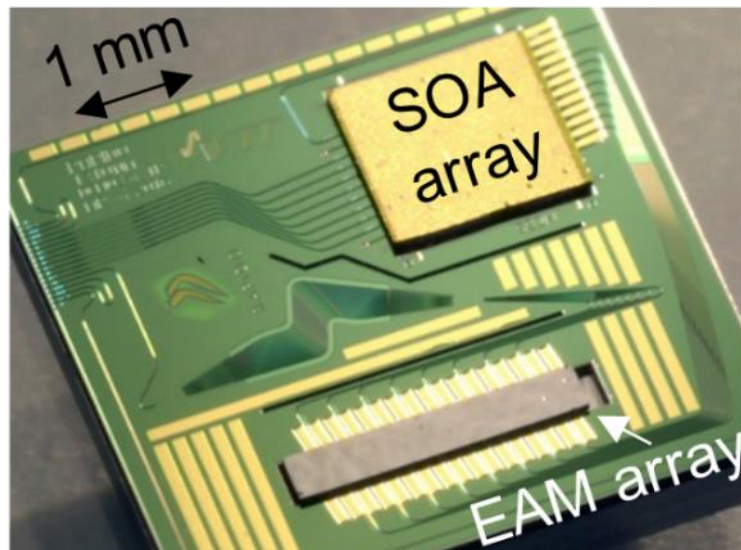
Assembly



# Hybrid integration of active components on 3 $\mu\text{m}$ SOI platform

VTT

- Lasers, amplifiers, modulators and photodetectors have been flip-chip bonded on 3  $\mu\text{m}$  SOI using Au-Au thermo compression bonding



5x5 mm SOI chip with 8-ch SOA and EAM arrays

EAM array being tested on SOI

InP EAM test result

# OUTLINE

ePIXfab

The options for light source integration

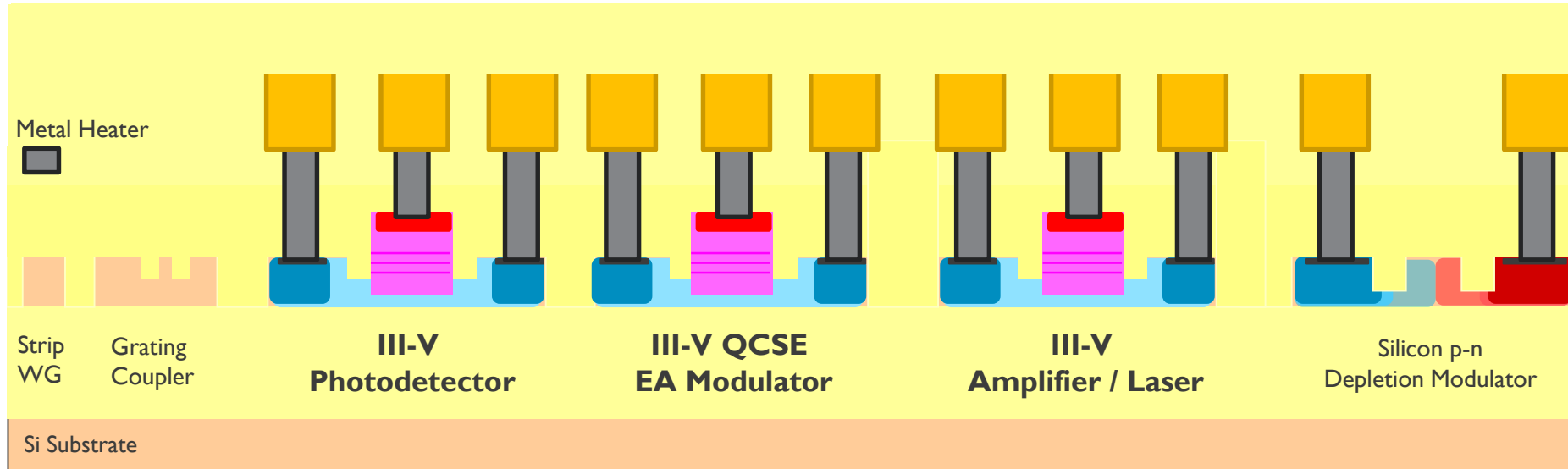
Work in progress in Europe

Short term to market

➡ Long term to market

Medium term to market

# Silicon Photonics 2.0 – Proposed Cross Section

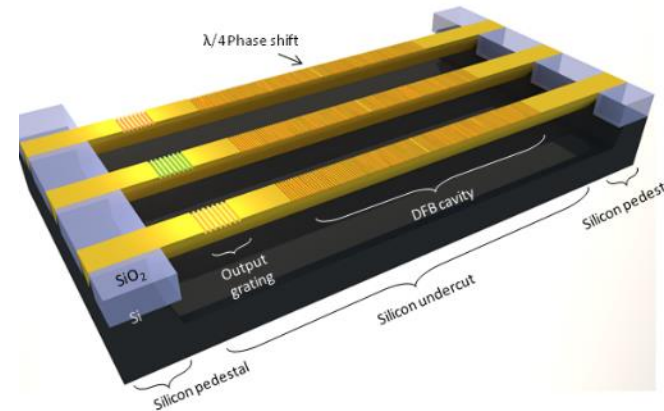
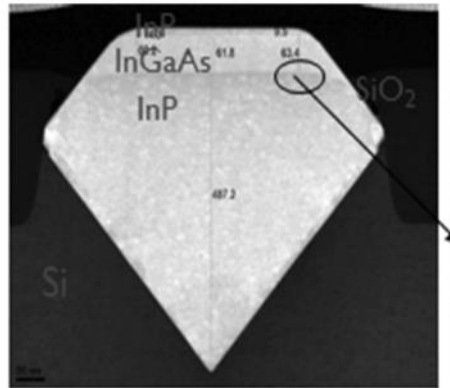


*Our long-term objectives for **monolithic III-V on Si lasers**:*

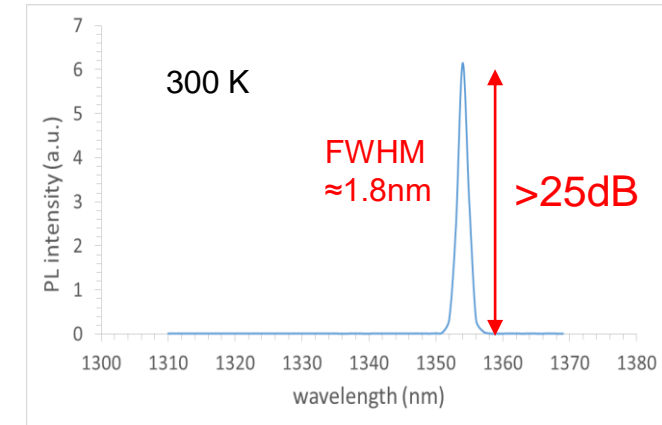
- Wafer-scale fabrication in 300mm CMOS fab: MOVPE
- Integrated in a silicon passive/active PIC → selective area growth
- Electrically driven, with high wall-plug efficiency (>10%)
- Efficient coupling to Si waveguide (<0.5dB)
- High temperature operation (>85C)
- High reliability, long lifetime → TDD <10<sup>6</sup>cm<sup>-2</sup>?
- Emission wavelength in O-band (datacom) or C-band (telecom)

# RAPID PROGRESS ON III-V ON SILICON HETERO-EPITAXY

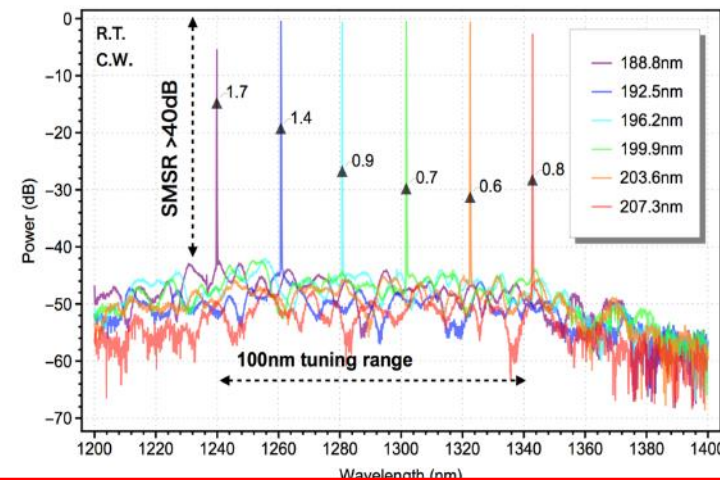
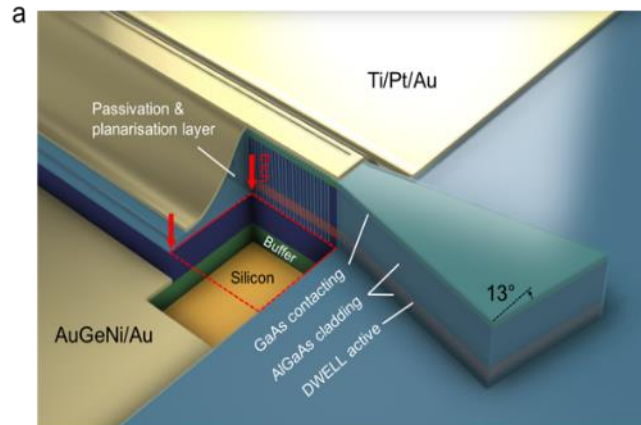
O-pumped InP DFB lasers (RT) @ imec



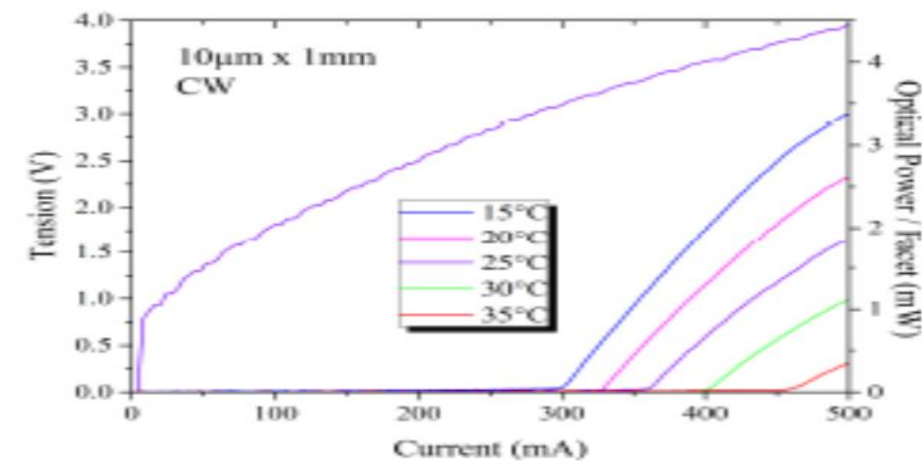
Laser emission spectra



E-pumped QD DFB lasers (RT, CW) @ UCL



E-pumped GaSb QW lasers (RT) @ U.Montpellier



Remaining big challenge: integration in the SiPh process flow

# OUTLINE

ePIXfab

The options for light source integration

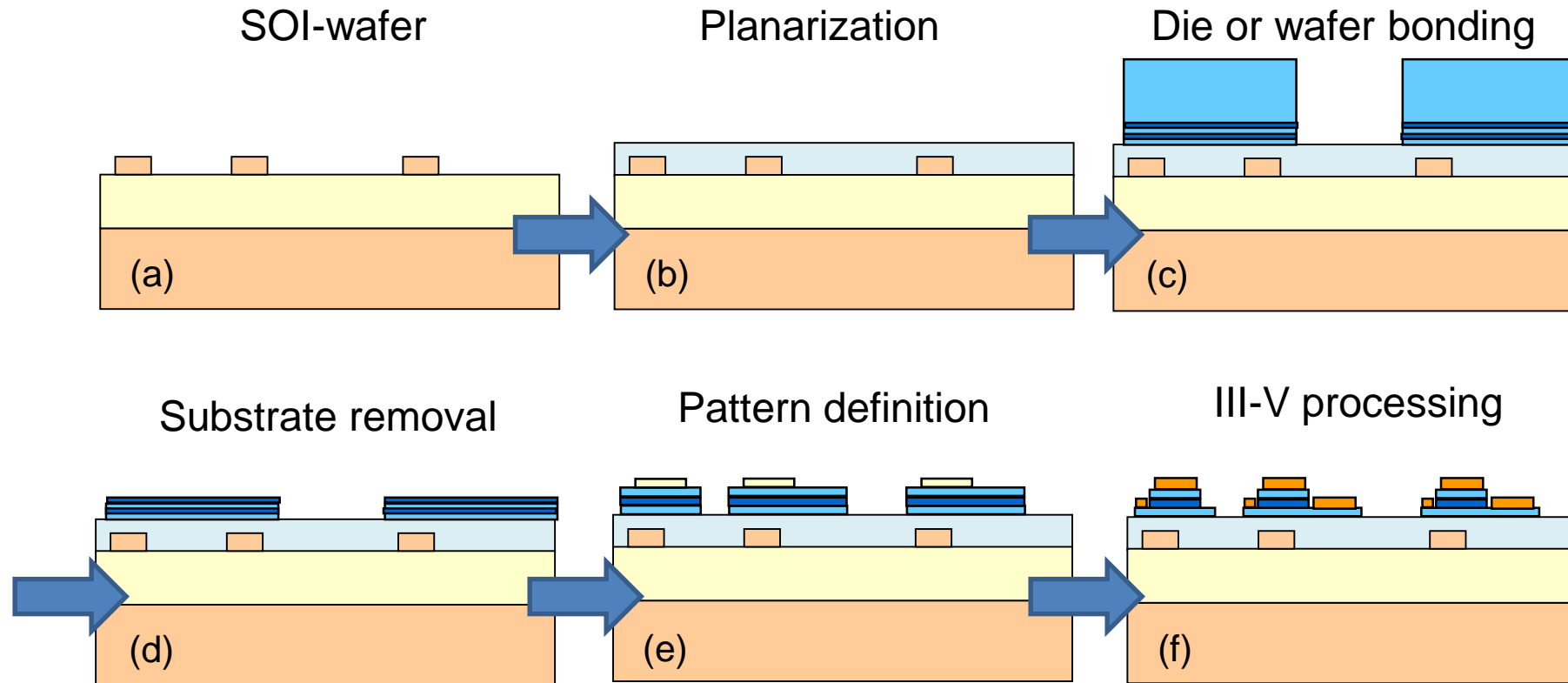
Work in progress in Europe

Short term to market

Long term to market

➡ Medium term to market

# III-V-on-silicon die-to-wafer bonding



# III-V INTEGRATION ACTIVITIES IN LETI

## Motivation:

- Large scale integration of III-V based device on CMOS compatible silicon photonic platform

## Components:

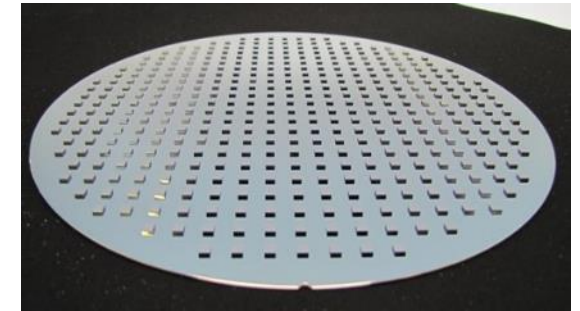
- Laser
- Electro-absorption modulator
- Semiconductor optical amplifier

## Specific process module developments:

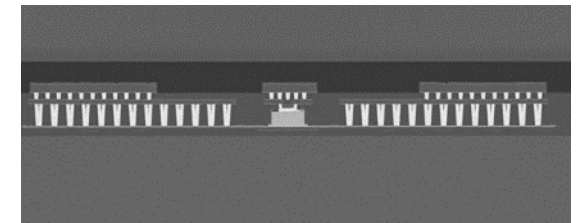
- Multi-die bonding on patterned SOI wafers
- **III-V patterning on 200 & 300mm wafers**
- **III-V contacts with cmos compatible materials**
- Back side integration

## References:

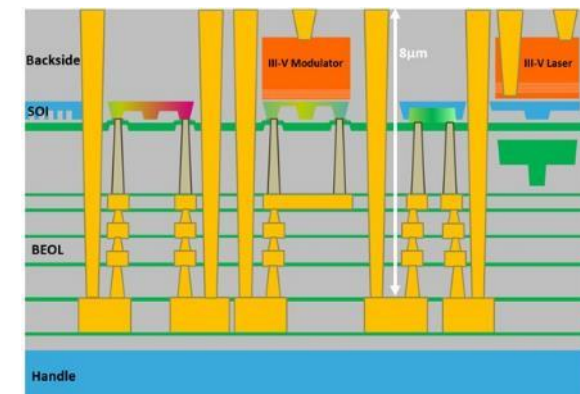
- A.Descos et al, ECOC 2013  
H. Duprez et al, Opt. Express 23(7), 8489 (2015)  
T. Ferrotti et al, SSDM 2016  
B. Szelag et al, IEDM 2017  
K. Hassan et al, SSDM 2018



*Die Bonding on 200 & 300mm Si wafers*



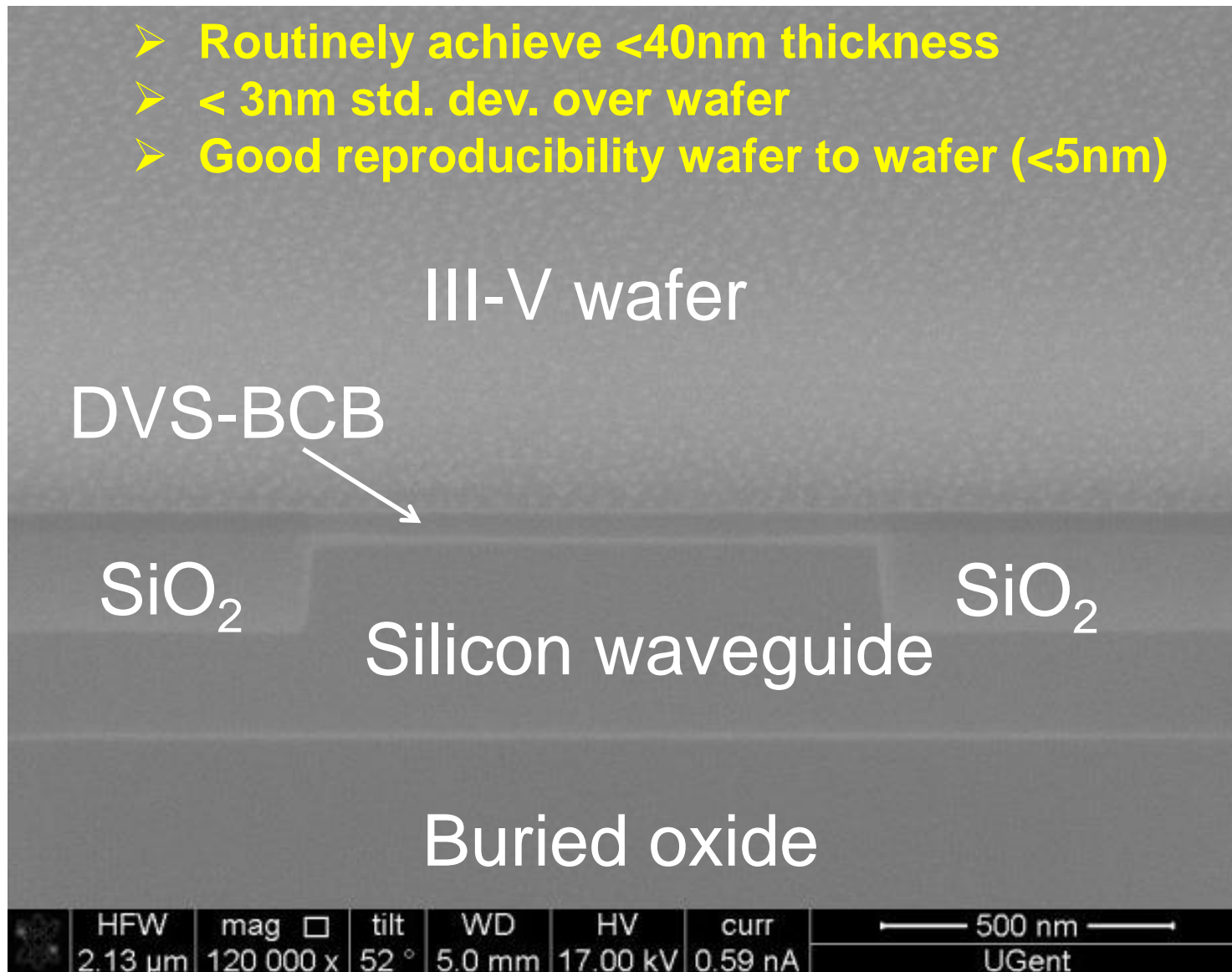
*III-V/Si Laser with multilevel planar BEOL*



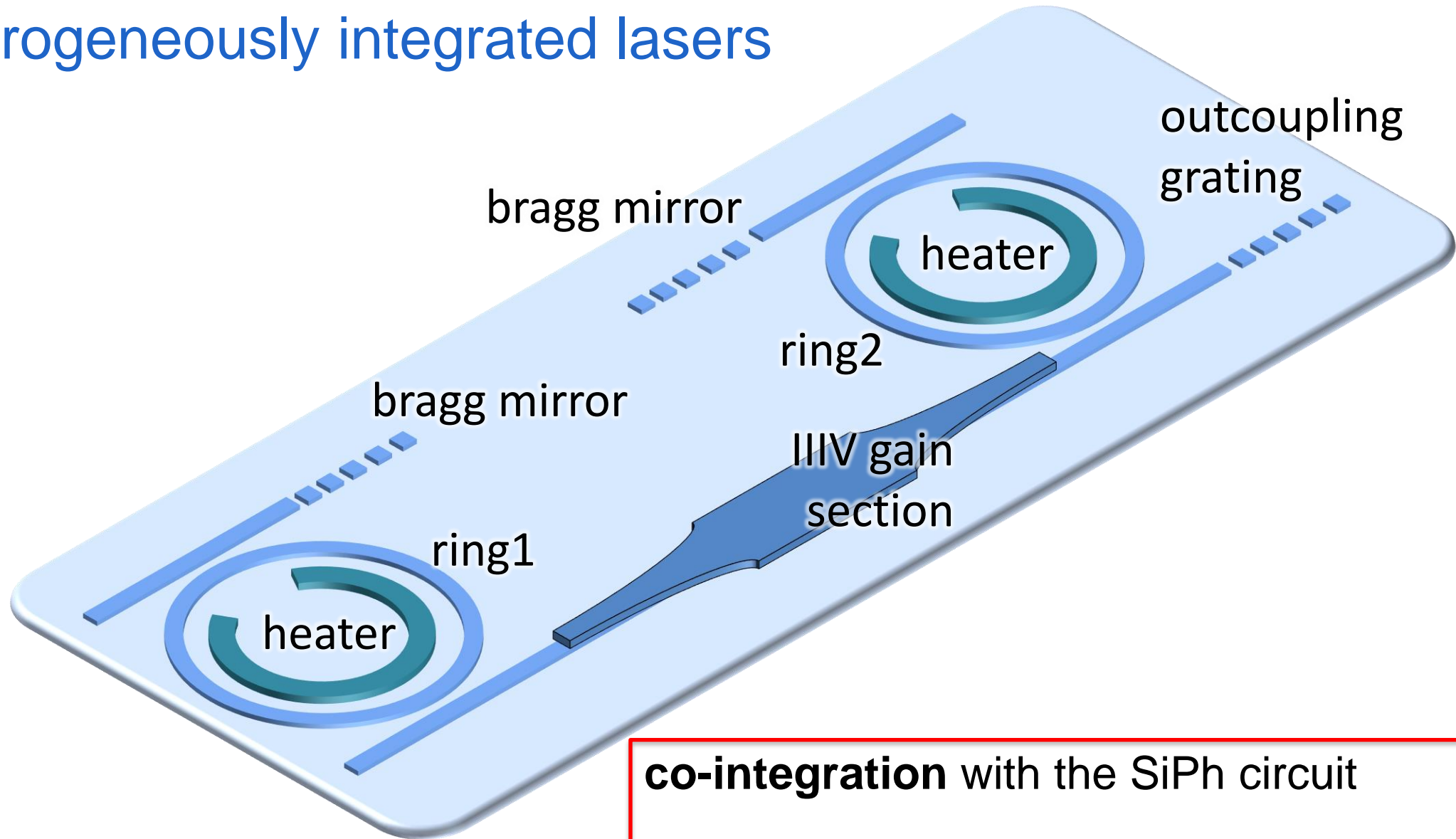
*III-V/Si components integrated on backside of a complex photonic platform*

# III-V-on-silicon die-to-wafer bonding

- Routinely achieve <40nm thickness
- < 3nm std. dev. over wafer
- Good reproducibility wafer to wafer (<5nm)



# Heterogeneously integrated lasers



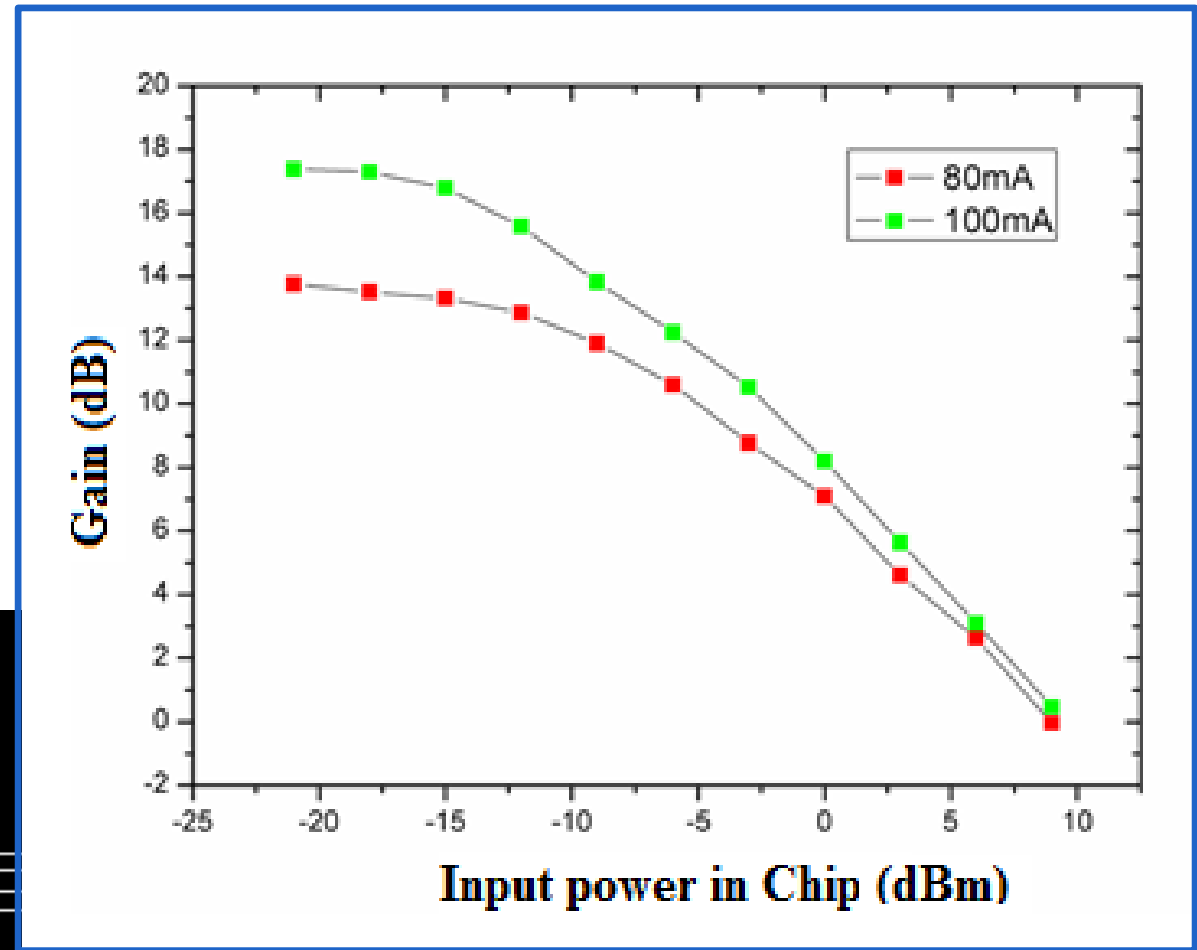
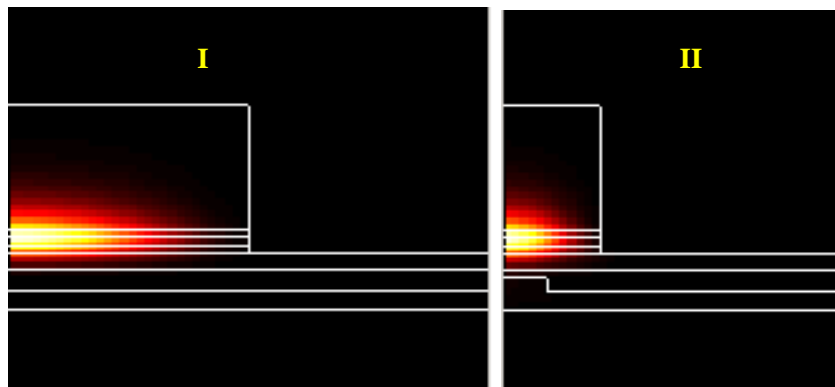
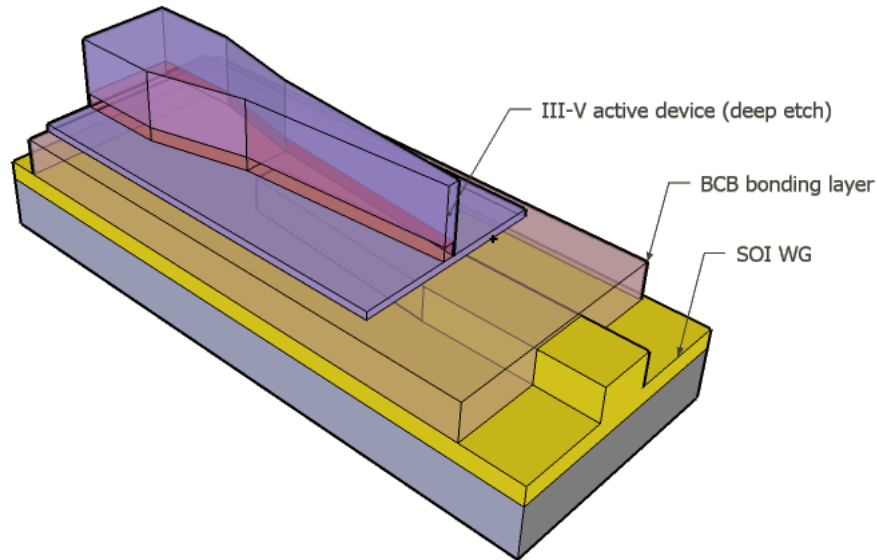
**co-integration with the SiPh circuit**

**advanced laser sources exploiting the high performance Si passive functions**

# InP-on-Si C-band lasers – SOAs

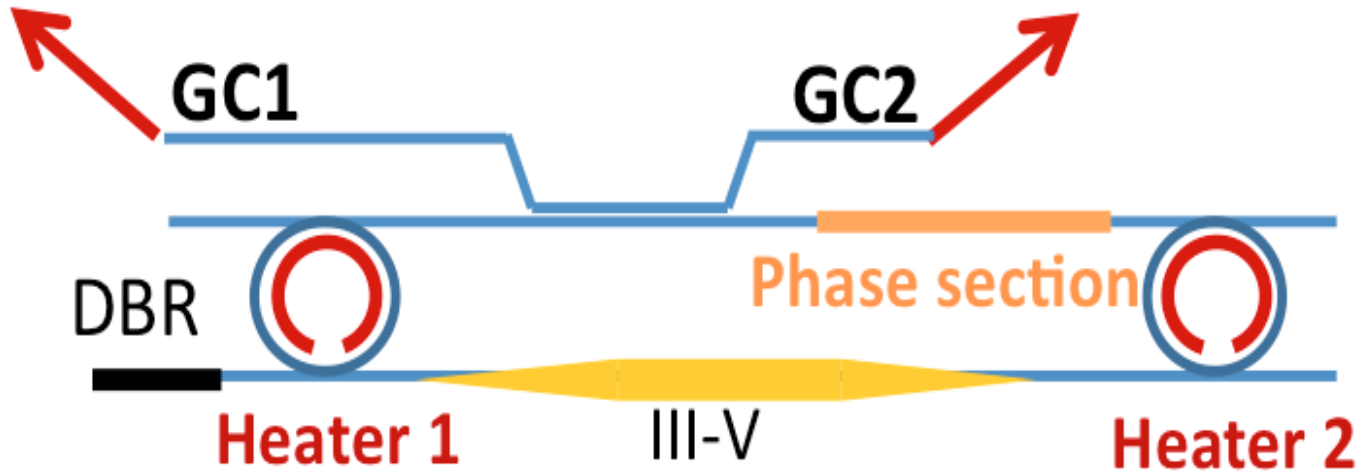
No exposed facets  
Intrinsically hermetically sealed

From full confinement in III-V to full confinement in SOI



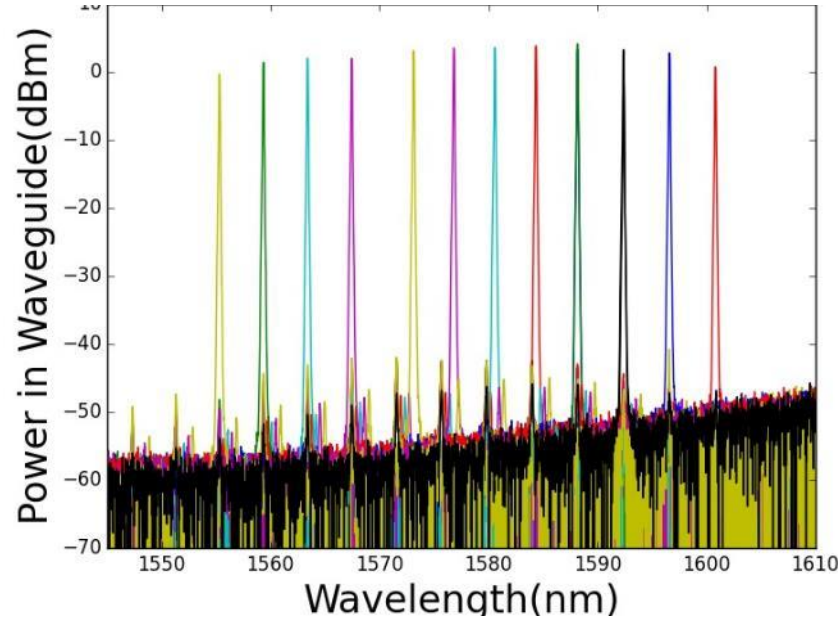
Fundamental mode in different cross-sections (BCB thickness=80nm)

# InP-on-Si C-band lasers – widely tunable lasers

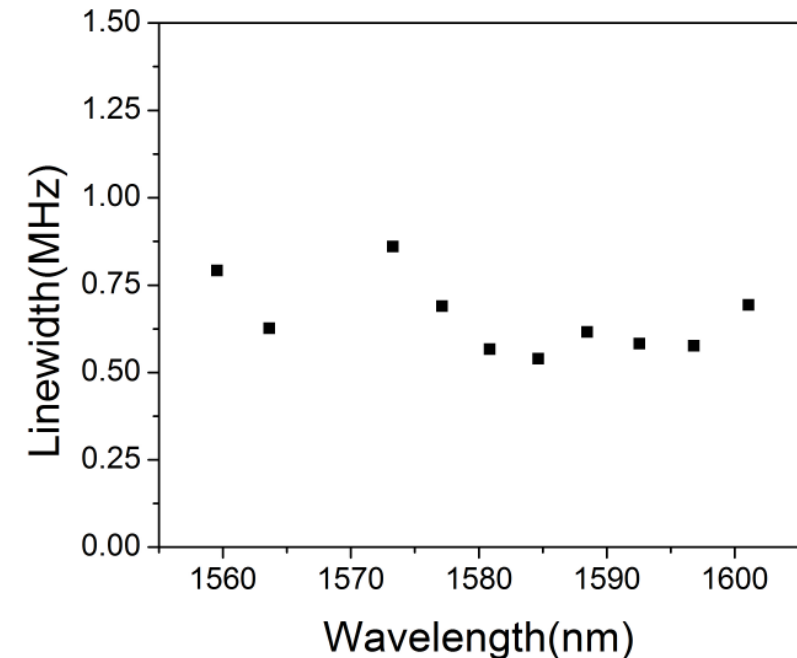


Using Vernier ring resonator filter wavelength tuning can be realized together with narrow linewidth

Including a DBR couples CW to CCW – leading to unidirectional operation

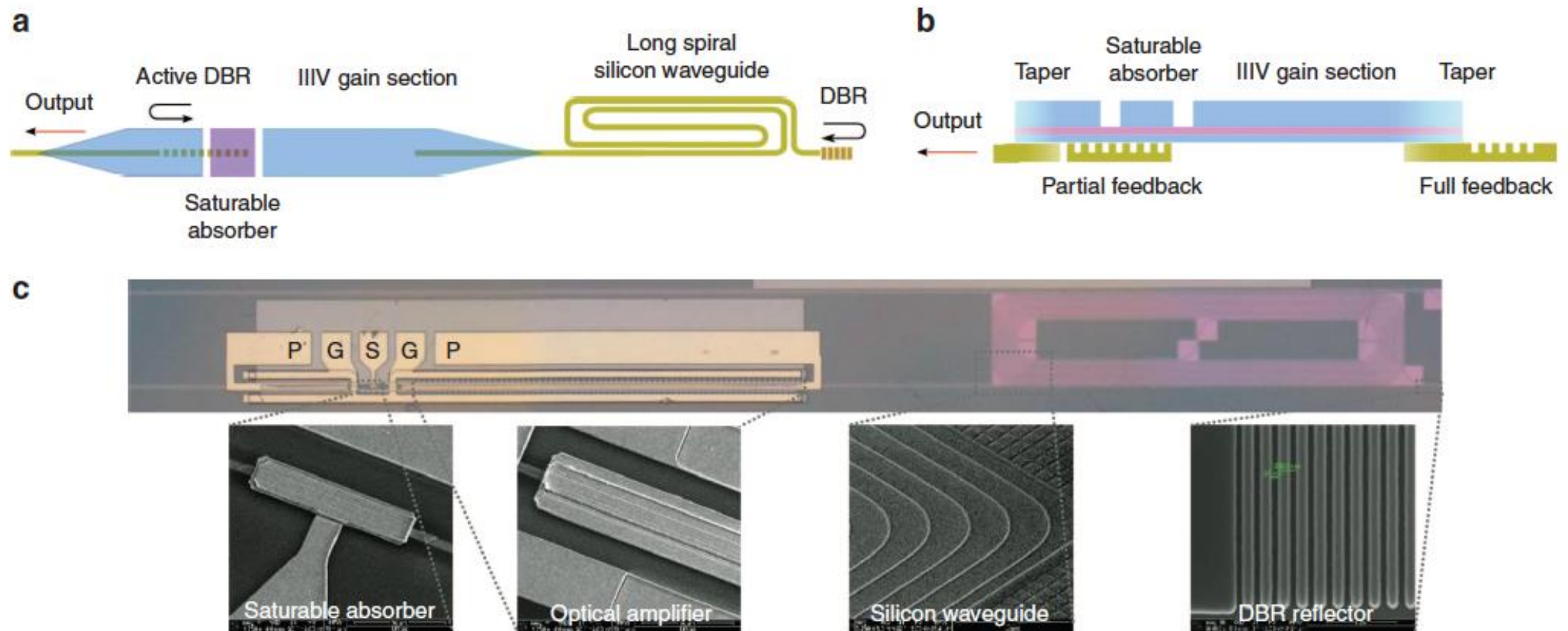


45 nm tuning range- SMSR > 40 dB



Linewidth between 500kHz and 850 kHz

# InP-on-Si C-band lasers – modelocked laser

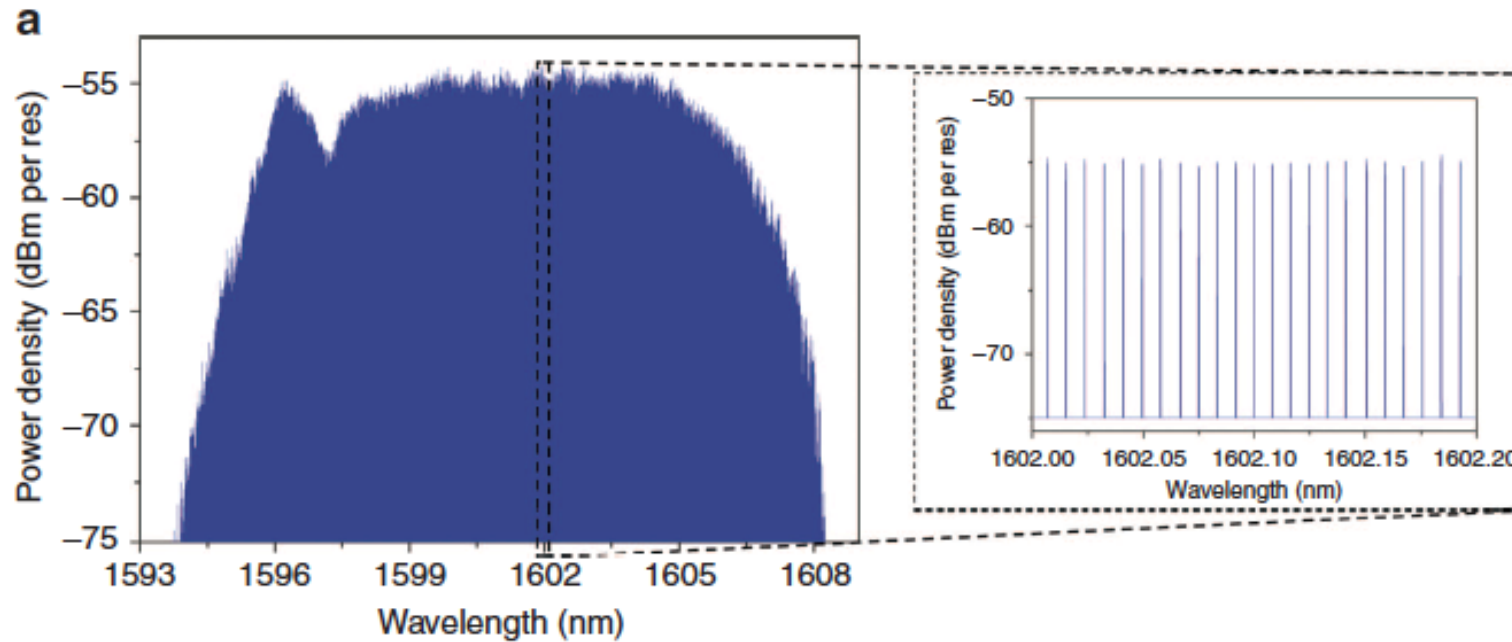


- 1GHz repetition rate modelocked laser (lowest rep rate obtained on integrated platform)
- III-V gain section, III-V saturable absorber & long Si waveguide (0.7dB/cm loss) to form the laser cavity

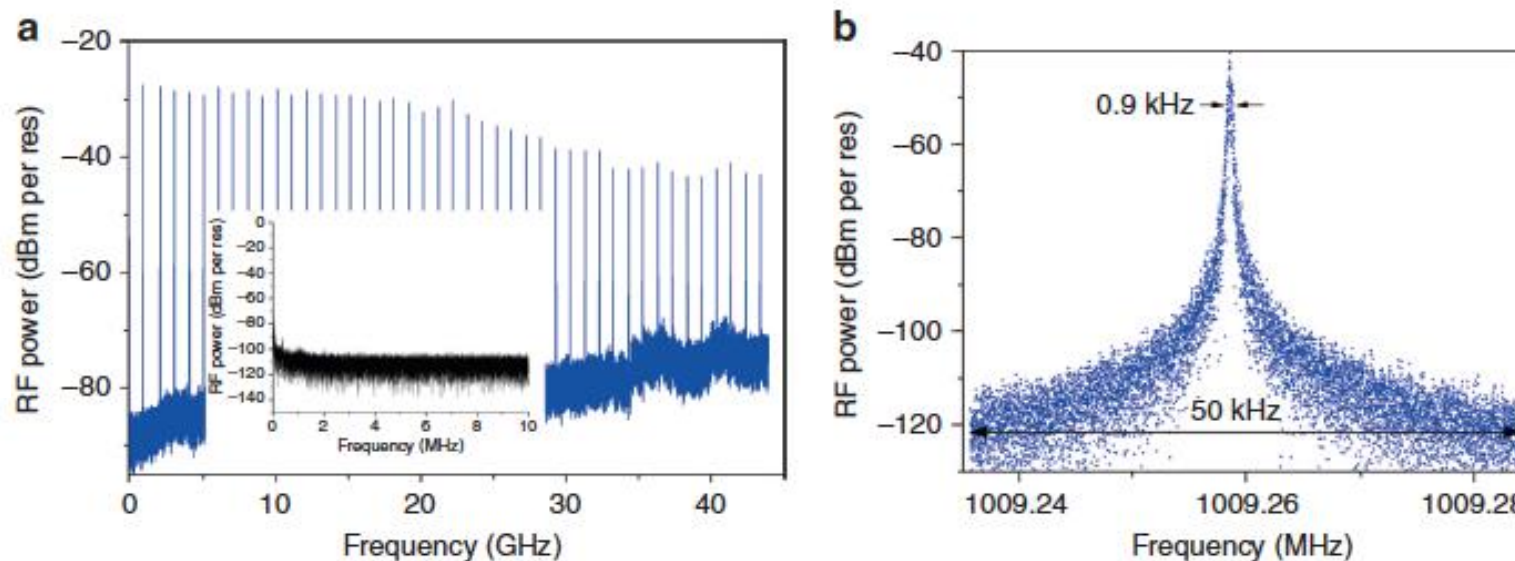
# InP-on-Si C-band lasers – modelocked laser

Passive modelocking

Optical spectrum

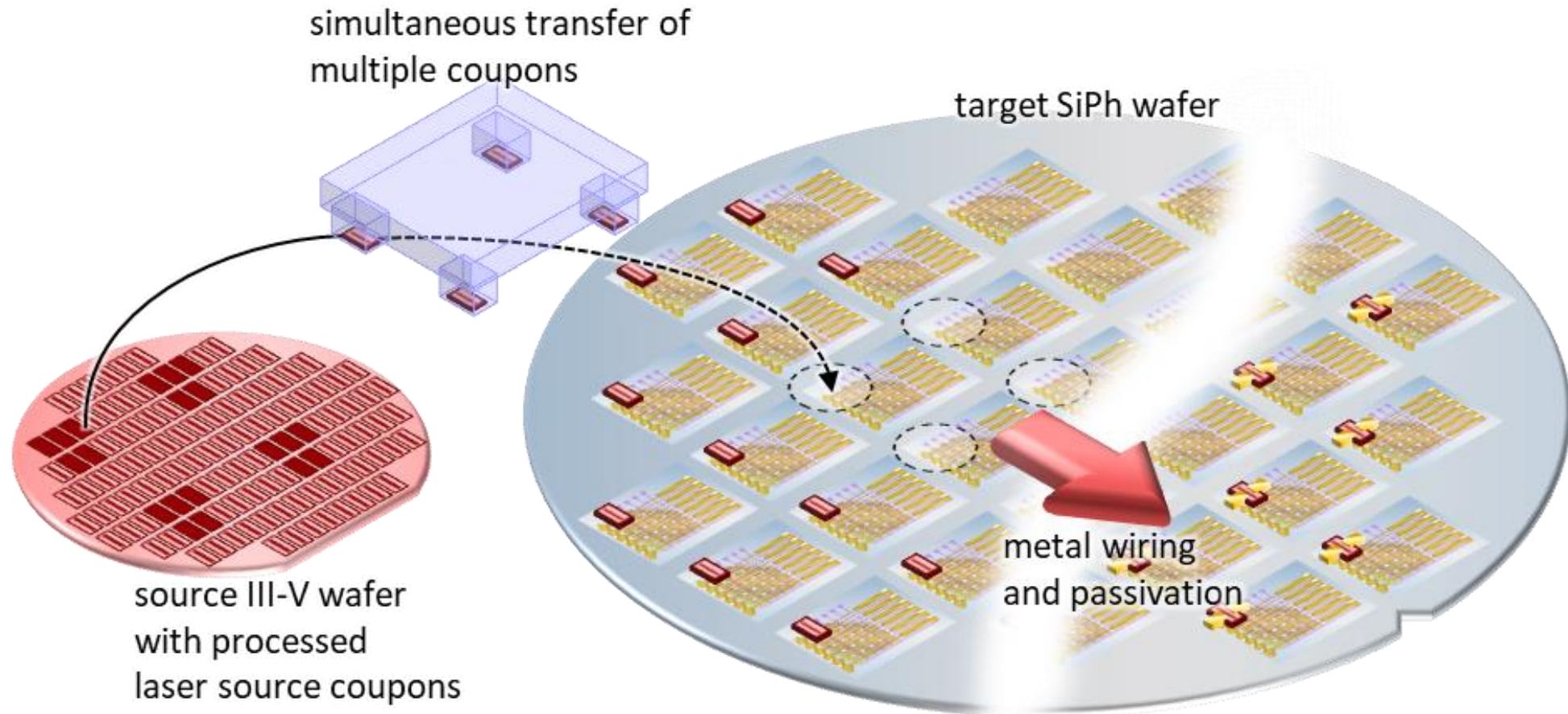


RF spectrum



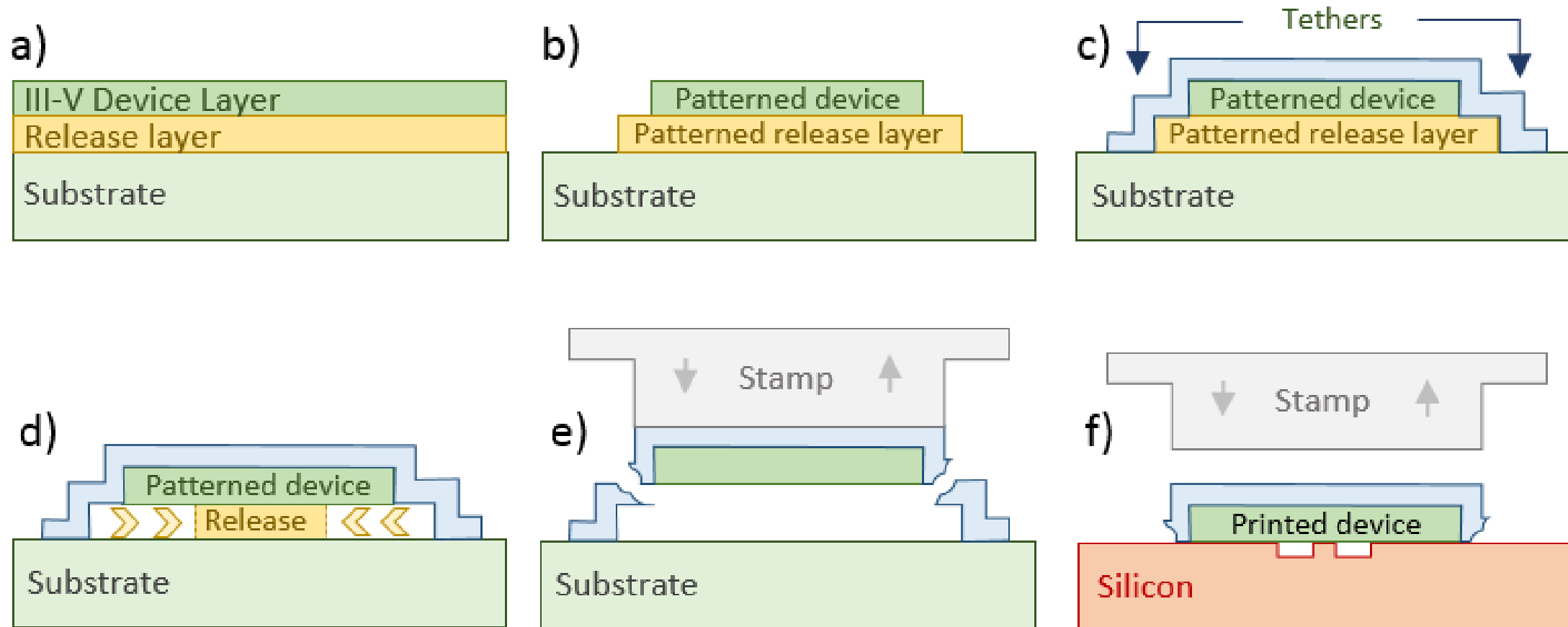
# Approaches to hybrid III-V integration on SiPhotonics

## Transfer printing



Combines advantages of pick-and-place/flip-chip/wafer bonding

# Transfer printing for III-V-on-silicon integration



Transfer of micro-scale III-V devices to a SiPhotonics target wafer

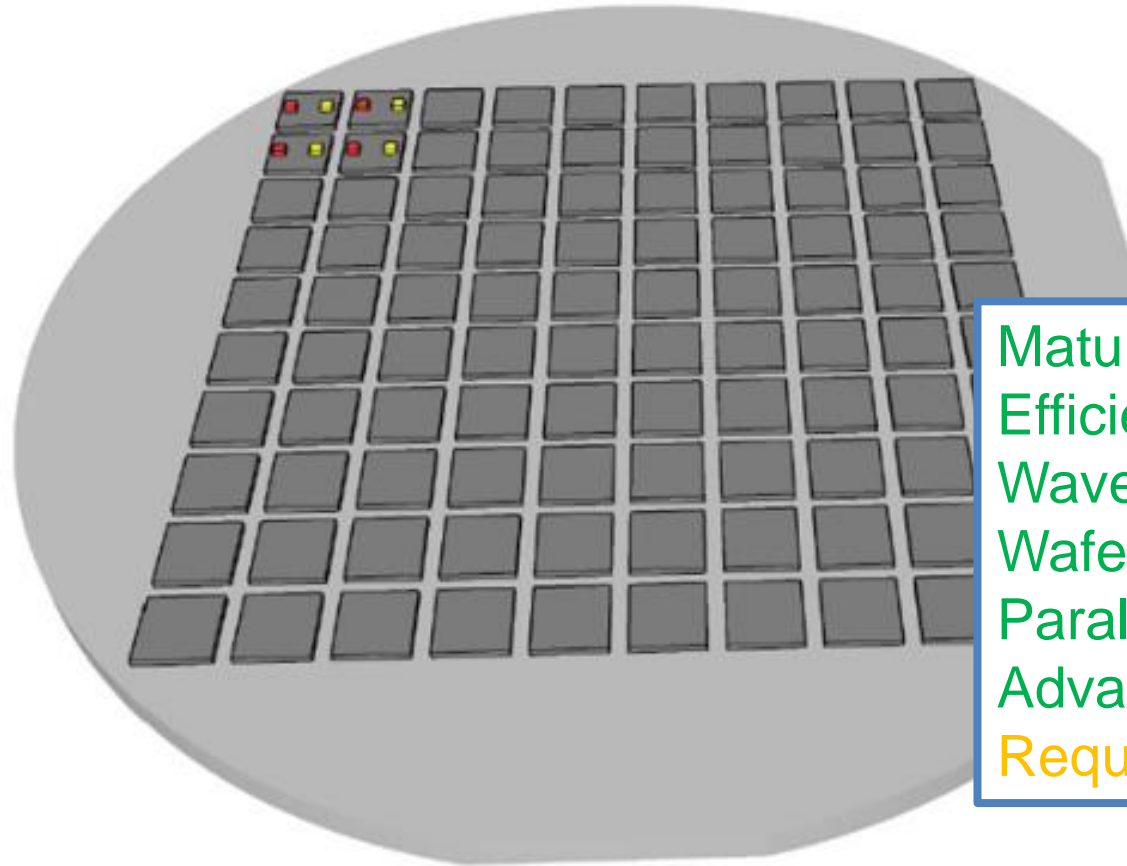
# Transfer printing for III-V-on-silicon

AREA MAGNIFICATION  
DENSE INTEGRATION

PDMS stamp



III-V source wafers

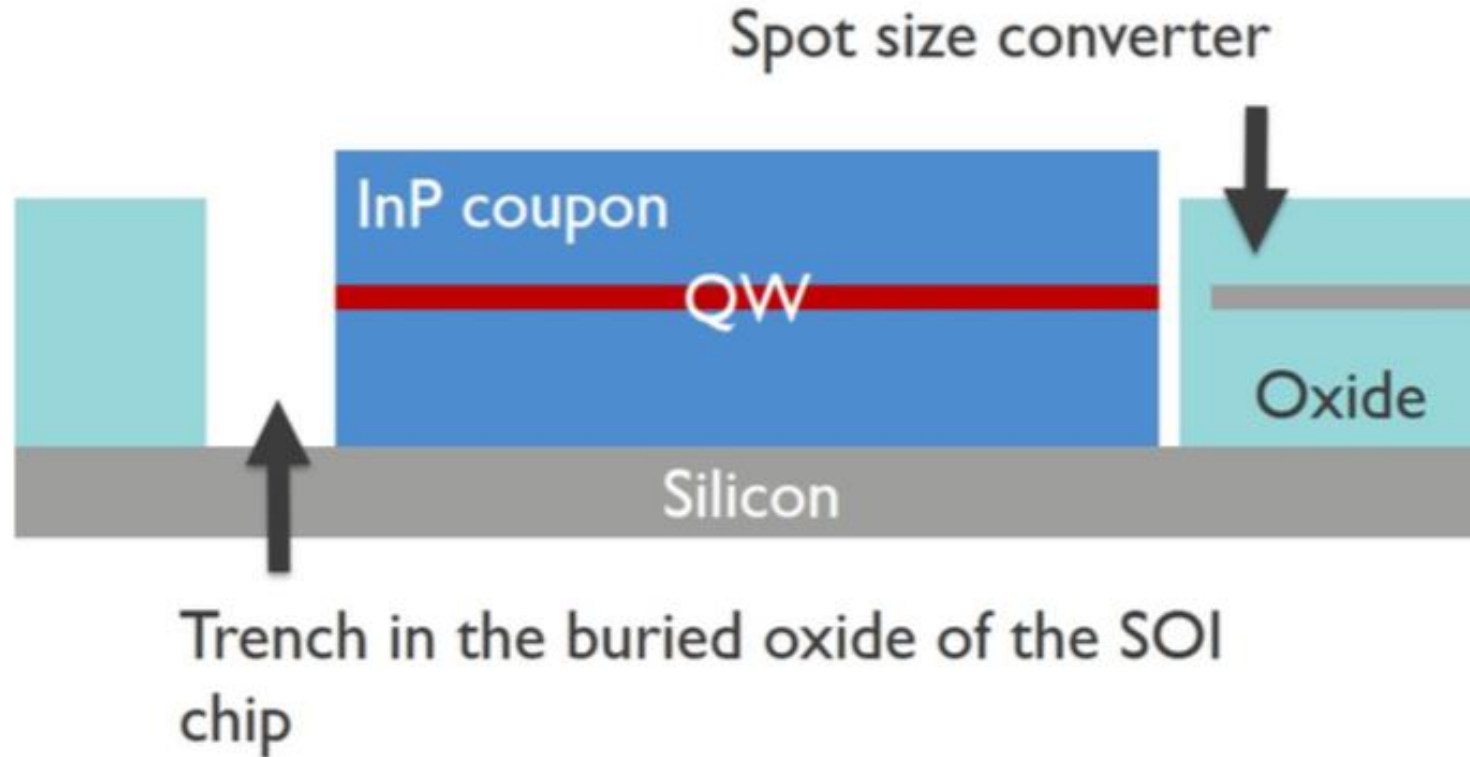


SOI target wafer

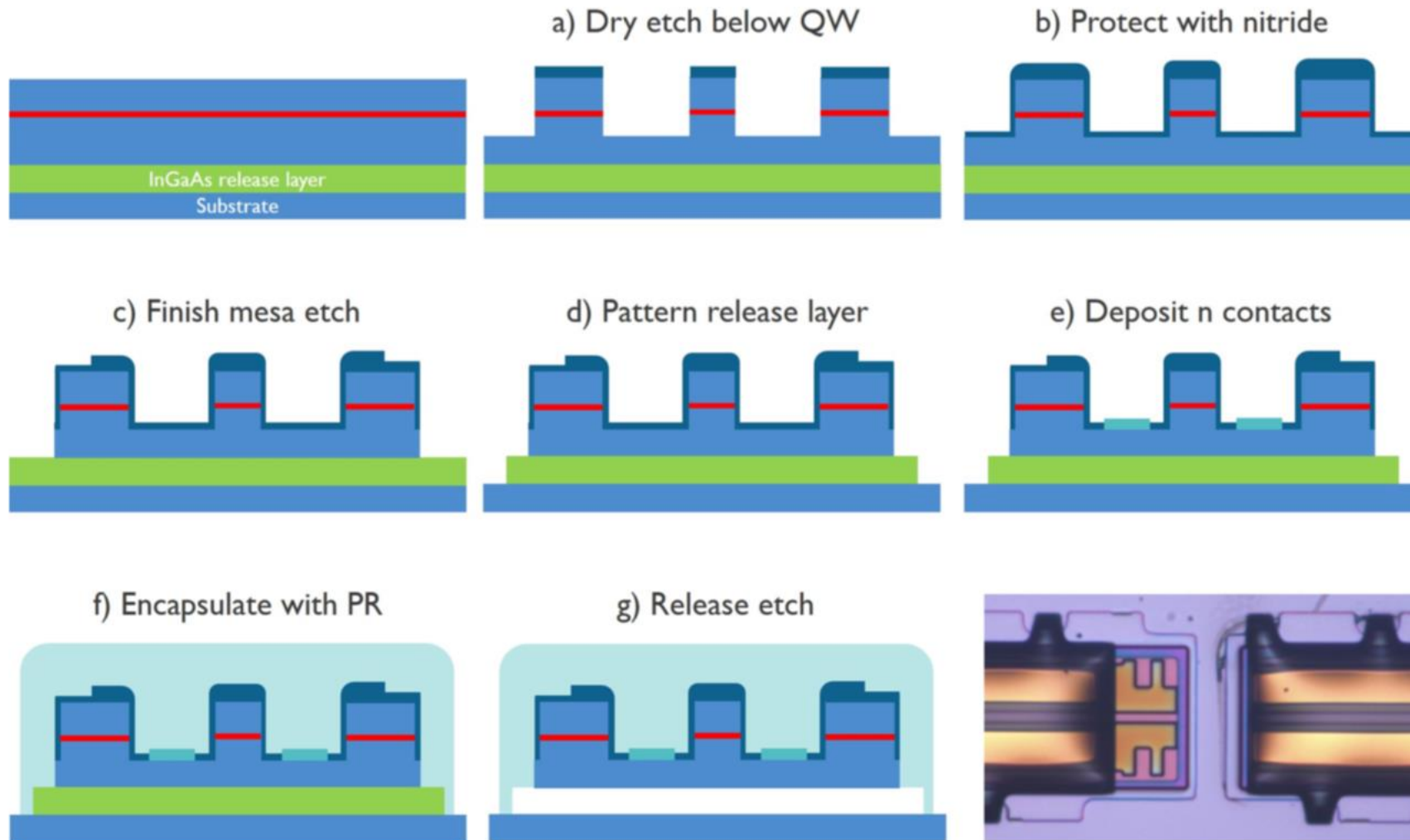
Mature InP processing  
Efficient optical coupling possible  
Waveguide in-out devices (SOA)  
Wafer-level test on source wafer  
Parallel assembly of devices  
Advanced laser sources  
Requires local back-end removal

1 inch stamp size  
30 sec per print cycle

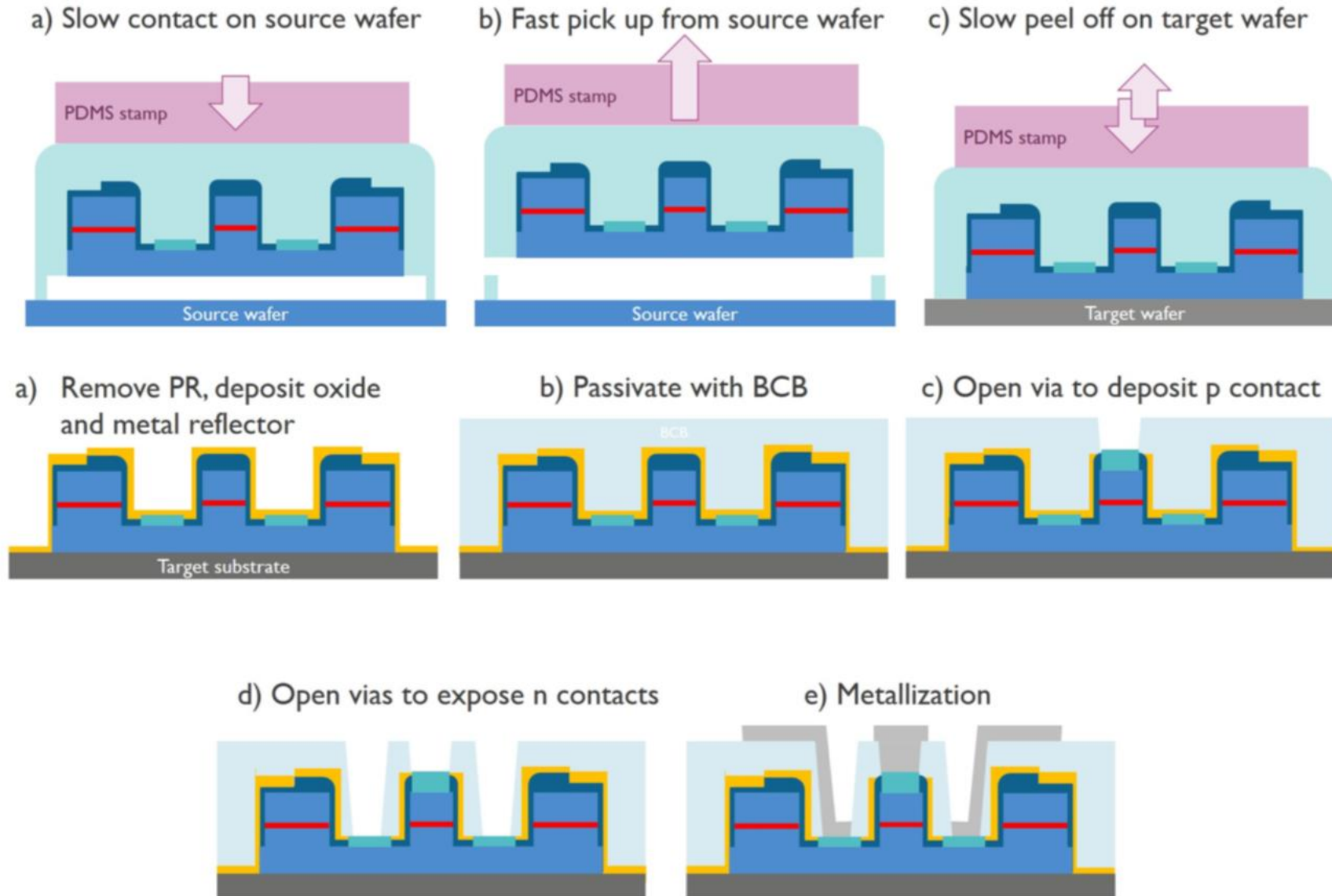
# TRANSFER PRINTING OF ARRAYS OF LASERS



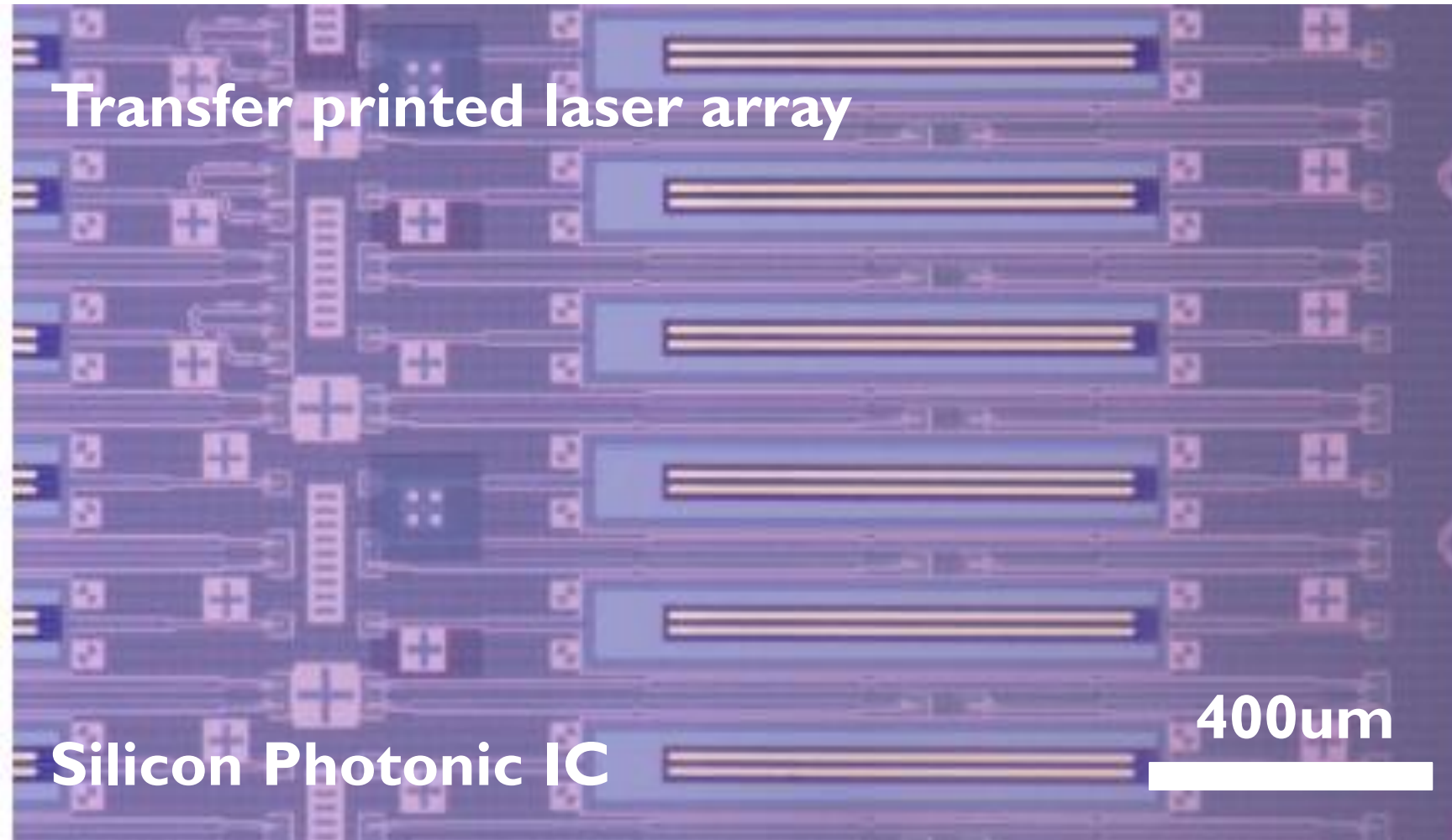
# TRANSFER PRINTING OF ARRAYS OF LASERS



# TRANSFER PRINTING OF ARRAYS OF LASERS



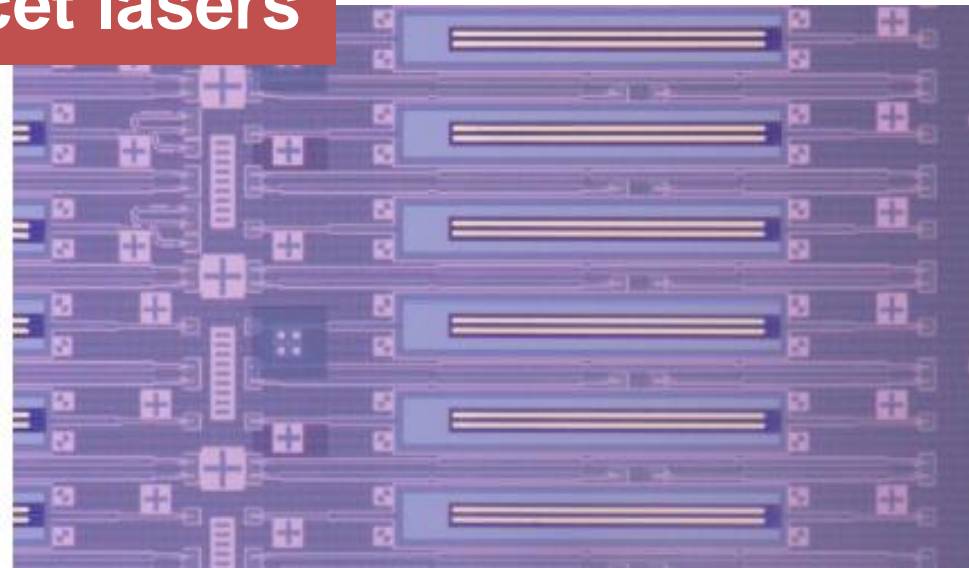
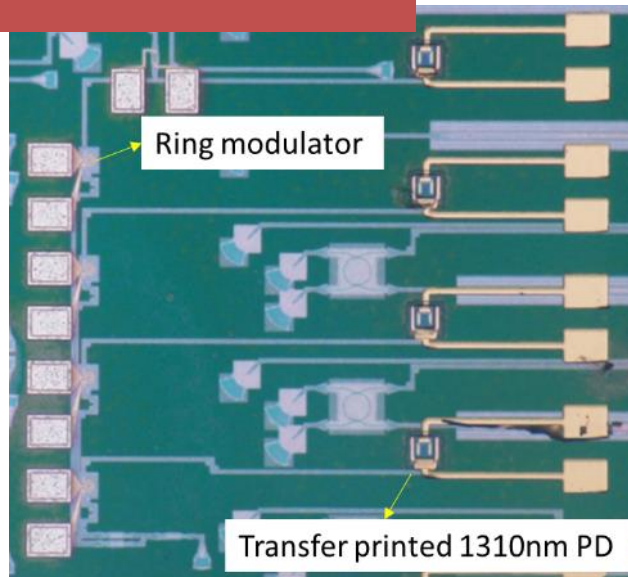
# TRANSFER PRINTING OF ARRAYS OF LASERS



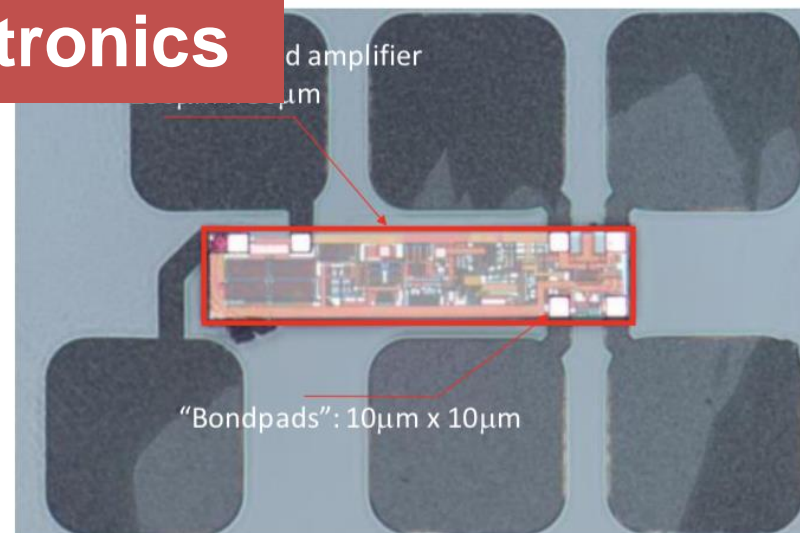
# Transfer printing: versatile integration

**Etched facet lasers**

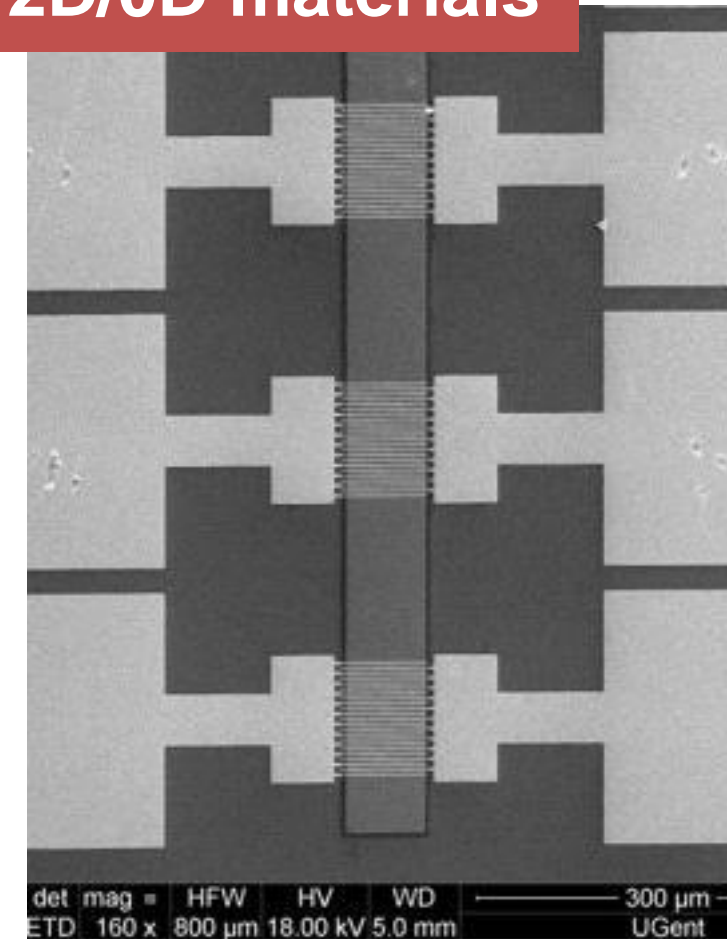
**photodiodes**



**electronics**



**2D/0D materials**



**etc. etc...**

# Conclusions

- Silicon photonics: is in the market with a diversity of “flavours”
- Light source integration:
  - Many options
  - Exciting and very fast scientific progress
  - But few options have an open-access industrial supply chain today
  - This will likely change in the next few years

# ACKNOWLEDGEMENT

## ePIXfab

in particular Tyndall, LETI and VTT

in particular Abdul Rahim (coordinator)

## imec

in particular Joris Van Campenhout and co-workers

## imec – Ghent University

in particular Gunther Roelkens, Dries Van Thourhout and Wim Bogaerts and co-workers